
PXIe-5841

Specifications



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PXIe-5841 Specifications

These specifications apply to the PXIe-5841.

Revision History

Version	Date changed	Description
377850C-01	March 2026	Entry level VST release update.

Looking For Something Else?

For information not found in the specifications for your product, such as operating instructions, browse *Related Information*.

Related information:

- [PXIe-5841 User Manual](#)

Definitions

Warranted specifications describe the performance of a model under stated operating conditions and are covered by the model warranty. Warranted specifications account for measurement uncertainties, temperature drift, and aging. Warranted specifications are ensured by design or verified during production and calibration.

Characteristics describe values that are relevant to the use of the model under stated operating conditions but are not covered by the model warranty.

- *Typical* specifications describe the performance met by a majority of models.
- *Typical-95* specifications describe the performance met by 95% ($\approx 2\sigma$) of models with a 95% confidence.
- *Nominal* specifications describe an attribute that is based on design, conformance testing, or supplemental testing.

- *Measured* specifications describe the measured performance of a representative model.

Specifications are *Warranted* unless otherwise noted.

Conditions

All specifications are valid under the following conditions unless otherwise noted.

- 30 minute warm-up time
- Self-calibration is performed after the specified warm-up period has completed
- Calibration cycle is maintained
- The chassis fan mode is set to Auto when used in a chassis with ≥ 58 W slot-cooling capability or the fan mode is set to High when used in any other chassis
- Empty chassis slots contain slot blockers and EMC filler panels to minimize temperature drift and reduce emissions
- Modules are connected with NI cables as shown in the *PXIe-5841 Getting Started Guide*
- RFmx, NI-RFSA, or NI-RFSG instrument driver is used
- Calibration IP is used properly during the creation of custom FPGA bitfiles

Typical specifications do not include measurement uncertainty and are measured immediately after a device self-calibration is performed.

Unless otherwise noted, specifications assume the PXIe-5841 is configured in the following default mode of operation:

- Reference Clock source: Onboard
- RF IN reference level: 0 dBm
- RF IN preamplifier: AUTO
- RF OUT power level: 0 dBm
- LO tuning mode: Fractional
- LO PLL loop bandwidth: Medium
- LO step size: 500 kHz
- LO frequency: 2.4 GHz
- LO source: Onboard LO

Unless otherwise noted, specifications assume the PXIe-5841 with the PXIe-5655 is

configured in the following default mode of operation:

- Reference Clock source: Onboard (from the PXIe-5655)
- RF IN reference level: 0 dBm
- RF IN preamplifier: AUTO
- RF OUT power level: 0 dBm
- LO tuning mode: Fractional
- LO PLL loop bandwidth: Low
- LO step size: 500 kHz
- LO frequency: 2.4 GHz
- LO source: Onboard LO (from the PXIe-5655)

Warranted specifications are valid over temperature ranges described in the *Environmental Characteristics* section of this document unless otherwise noted.

Specifications are identical for the PXIe-5841 and the PXIe-5841 with the PXIe-5655 unless otherwise noted.

PXIe-5841 Pinout

Use the pinout to connect to terminals on the PXIe-5841.

Figure 1. PXle-5841 Digital I/O Connector Pinout

Reserved	A1	B1	5.0 V
GND	A2	B2	GND
MGT Rx+ 0	A3	B3	MGT Tx+ 0
MGT Rx- 0	A4	B4	MGT Tx- 0
GND	A5	B5	GND
MGT Rx+ 1	A6	B6	MGT Tx+ 1
MGT Rx- 1	A7	B7	MGT Tx- 1
GND	A8	B8	GND
DIO 4	A9	B9	DIO 6
DIO 5	A10	B10	DIO 7
GND	A11	B11	GND
MGT REF+ / DIO 0	A12	B12	DIO 2
MGT REF- / DIO 1	A13	B13	DIO 3
GND	A14	B14	GND
MGT Rx+ 2	A15	B15	MGT Tx+ 2
MGT Rx- 2	A16	B16	MGT Tx- 2
GND	A17	B17	GND
MGT Rx+ 3	A18	B18	MGT Tx+ 3
MGT Rx- 3	A19	B19	MGT Tx- 3
GND	A20	B20	GND
5.0 V	A21	B21	Reserved

Table 1. PXIe-5841 Digital I/O Signal Descriptions

Signal	Type	Direction
MGT Tx± <3..0>	Xilinx Virtex-7 GTH	Output
MGT Rx± <3..0>	Xilinx Virtex-7 GTH	Input
MGT REF±	Differential	Input
DIO <1..0>	Single-ended	Bidirectional
DIO <7..2>	Single-ended	Bidirectional
5.0 V	DC	Output
GND	Ground	—



Note DIO <1..0> pins are multiplexed with MGT REF±.

Physical Characteristics



Note Refer to the *PXIe-5655 Specifications* for information on the PXIe-5655 physical characteristics.

PXIe-5841 module dimensions	2U, two slot, PXI Express module 4.1 cm × 12.9 cm × 21.1 cm (1.6 in. × 5.6 in. × 8.3 in.)
Weight	794 g (28.0 oz)

Common NI Terminology for RF Settings

Refer to the following list for definitions of common NI terms related to software-configured settings for the PXIe-5841 and used throughout this document.

Table 2. Common Terminology Definitions

Term	Definition
<i>Center Frequency</i>	Refers to the IQ Carrier Frequency property in NI-RFSA, the Frequency property in NI-RFSG, and the Center Frequency property in RFmx.
<i>Offset Mode is Automatic</i>	<p>Refers to the NI-RFSA Downconverter Frequency Offset Mode property or NI-RFSG Upconverter Frequency Offset Mode property set to Automatic.</p> <p>The PXIe-5841 uses a direct conversion architecture. Offset Mode allows the instrument to operate in low IF mode, which increases the separation between the signal of interest and the residual sideband image and residual LO leakage power. However, low IF mode limits the available instantaneous bandwidth. A setting of Automatic allows the driver to set Offset Mode to Enabled when the signal bandwidth is configured as small enough to allow it. You can read back the Offset Mode to determine if the driver selected Enabled or User-Defined.</p> <p>Automatic is the default value. NI recommends keeping Offset Mode set to the default value.</p>
<i>Offset Mode is Enabled</i>	<p>Refers to the NI-RFSA Downconverter Frequency Offset Mode property or NI-RFSG Upconverter Frequency Offset Mode property set to Enabled.</p> <p>Equivalent to $Signal\ Bandwidth \leq Maximum\ Offset\ Bandwidth$.</p> <p>The PXIe-5841 uses a direct conversion architecture. Offset Mode allows the instrument to operate in low IF mode, which increases the separation between the signal of interest and the residual sideband image and residual LO leakage power.</p>
<i>Offset Mode is User-Defined</i>	Refers to the NI-RFSA Downconverter Frequency Offset Mode property or NI-RFSG Upconverter Frequency Offset Mode property set to User-Defined.

Term	Definition
	<p>Equivalent to <i>Signal Bandwidth > Maximum Offset Bandwidth</i>.</p> <p>The PXIe-5841 uses a direct conversion architecture. Offset Mode set to User-Defined allows the instrument to operate with maximum instantaneous bandwidth.</p>
<i>Onboard</i>	Refers to the value of the LO Source property. A value of Onboard configures the hardware to use the PXIe-5841 LO on an associated PXIe-5655 (if present).

Center Frequency Range

The following characteristics are common to both RF IN and RF OUT ports.

Frequency range	9 kHz to 6 GHz
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Equalized Bandwidth

Table 3. PXIe-5841 Maximum Bandwidth (Offset Mode is User-Defined)

Center Frequency	1 GHz Bandwidth Option	200 MHz Bandwidth Option
9 kHz to <120 MHz	<120 MHz	<120 MHz
120 MHz to 410 MHz	50 MHz	50 MHz
>410 MHz to 650 MHz	100 MHz	100 MHz
>650 MHz to 1.3 GHz	200 MHz	200 MHz
>1.3 GHz to 2.2 GHz	500 MHz	200 MHz
>2.2 GHz to 6 GHz	1 GHz	200 MHz

The PXIe-5841 uses the low frequency subsystem to directly acquire or generate the RF signal below 120 MHz.

Table 4. PXIe-5841 Maximum Bandwidth (Offset Mode is Enabled)

I/Q Carrier Frequency	1 GHz Bandwidth Option	200 MHz Bandwidth Option
9 kHz to <120 MHz	—	—
120 MHz to 378 MHz	10 MHz	10 MHz
>378 MHz to 593 MHz	35 MHz	35 MHz
>593 MHz to 1.168 GHz	85 MHz	85 MHz
>1.168 GHz to 1.943 GHz	235 MHz	100 MHz
>1.943 GHz to 6 GHz	485 MHz	100 MHz

The PXIe-5841 uses the low frequency subsystem to directly acquire or generate the RF signal below 120 MHz.

Tuning resolution	888 nHz
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Note Tuning resolution combines LO step size capability and frequency shift digital signal processing (DSP) implemented on the FPGA.

Table 5. LO Step Size

Fractional mode		Programmable step size, 500 kHz default
Integer mode	LO ≤ 4 GHz	10 MHz, 20 MHz, 25 MHz, 50 MHz, 100 MHz
	LO > 4 GHz	20 MHz, 50 MHz, 100 MHz, 200 MHz

In integer mode, larger step sizes improve phase noise performance.

Frequency Settling Time

Table 6. Frequency Settling Time, Typical (PXIe-5841)

Accuracy	Settling Time (μs)
≤1.0 × 10 ⁻⁶ of final frequency	<380
≤0.1 × 10 ⁻⁶ of final frequency	<400

Accuracy	Settling Time (μs)
This specification includes only frequency settling and excludes any residual amplitude settling.	

Table 7. Frequency Settling Time, Typical (PXIe-5841 with PXIe-5655)

Accuracy	Maximum Time (μs), 0 °C to 55 °C
$\leq 1.0 \times 10^{-6}$ of final frequency	<175 μs
$\leq 0.1 \times 10^{-6}$ of final frequency or ± 25 Hz, whichever is greater	<200 μs

Internal Frequency Reference



Note Specifications are improved when using the PXIe-5655. Refer to the *Internal Frequency Reference* section of the *PXIe-5655 Specifications* for more information.

Initial adjustment accuracy	$\pm 200 \times 10^{-9}$
Temperature stability	$\pm 1 \times 10^{-6}$, maximum
Aging	$\pm 1 \times 10^{-6}$ per year, maximum
Accuracy	<i>Initial adjustment accuracy \pm Aging \pm Temperature stability</i>

Spectral Purity

Table 8. Single Sideband Phase Noise (PXIe-5841)

LO Frequency	Phase Noise (dBc/Hz, Single Sideband), 20 kHz Offset, Self-Calibration °C ± 10 °C
<3 GHz	-102
3 GHz to 4 GHz	-102
>4 GHz to 6 GHz	-96

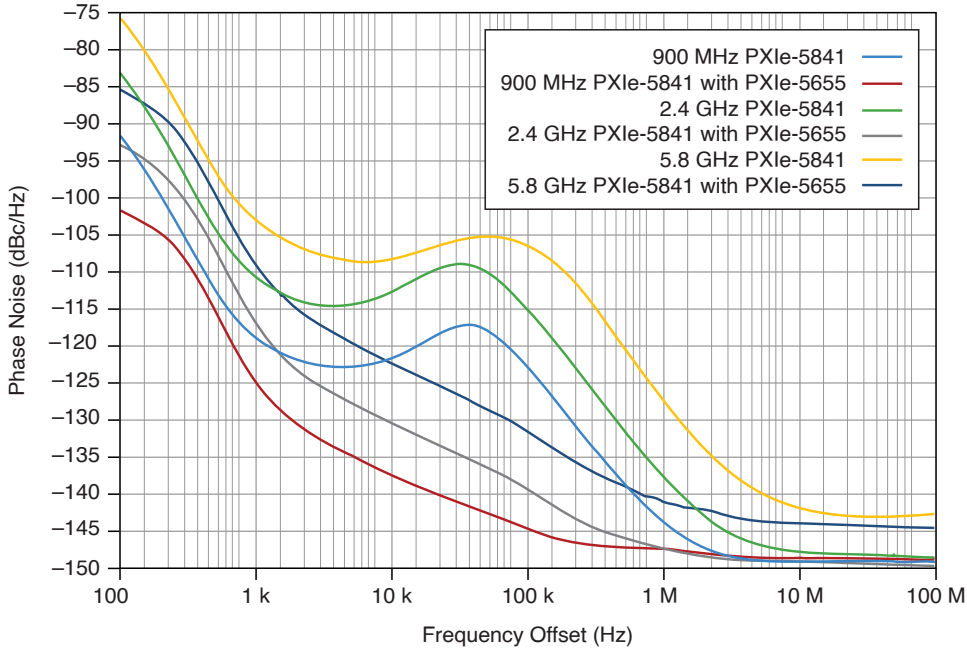
Table 9. Output Single Sideband Phase Noise (PXIe-5841 with PXIe-5655)

LO Frequency	Phase Noise (dBc/Hz, Single Sideband), 10 kHz Offset		Phase Noise (dBc/Hz, Single Sideband), 100 kHz Offset	
	Specification	Typical	Specification	Typical
900 MHz	—	-134.0	—	-141.0
2.4 GHz	-122.0	-127.0	—	-133.6
5.8 GHz	-115.0	-120.9	-123.0	-130.6

Warranted specification is for 23°C ± 5 °C .

Reference clock is PXIe-5655 internal OCXO.

Figure 2. Measured Phase Noise for PXIe-5841 and PXIe-5655



Conditions: Measured Port: RF OUT; Reference Clock: Onboard; Spurs not shown.

RF Input

RF Input Amplitude Range

Table 10. Input Amplitude Range, Nominal

Downconverter Center Frequency	Preamp	RF Input (dB)
9 kHz to <120 MHz	Disabled	Average noise level to +15 dBm continuous wave root-mean-square (CW RMS)
	Auto	
120 MHz to 6 GHz	Disabled	Average noise level to +30 dBm CW RMS
	Auto	
	Enabled	Average noise level to -10 dBm CW RMS

RF gain resolution	1 dB, nominal
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Table 11. Input RF Analog Gain Range, Preamp Auto, Nominal

Downconverter Center Frequency	RF Analog Gain Range (dB)
10 MHz to <120 MHz	≥35
120 MHz to 500 MHz	≥65
>500 MHz to 1.5 GHz	≥65
>1.5 GHz to 2.3 GHz	≥60
>2.3 GHz to 2.9 GHz	≥60
>2.9 GHz to 4.8 GHz	≥55
>4.8 GHz to 6 GHz	≥50

Table 12. Input RF Analog Gain Range, Preamp Enabled, Nominal

Downconverter Center Frequency	RF Analog Gain Range (dB)
120 MHz to 500 MHz	≥30
>500 MHz to 1.5 GHz	≥30
>1.5 GHz to 2.3 GHz	≥25
>2.3 GHz to 2.9 GHz	≥25
>2.9 GHz to 4.8 GHz	≥25
>4.8 GHz to 6 GHz	≥20

RF Input Amplitude Settling Time

<0.5 dB of final value	40 μ s, typical
<0.1 dB of final value	70 μ s, typical

Conditions: constant RF input signal, varying input reference level.

RF Input Relative Amplitude Accuracy

Table 13. Input Relative Amplitude Accuracy (dB)

Center Frequency	Typical
10 MHz to <120 MHz	± 0.35
120 MHz to 6 GHz	± 0.2

Relative accuracy describes the residual absolute error when compared to the absolute accuracy error at 0 dBm reference level.

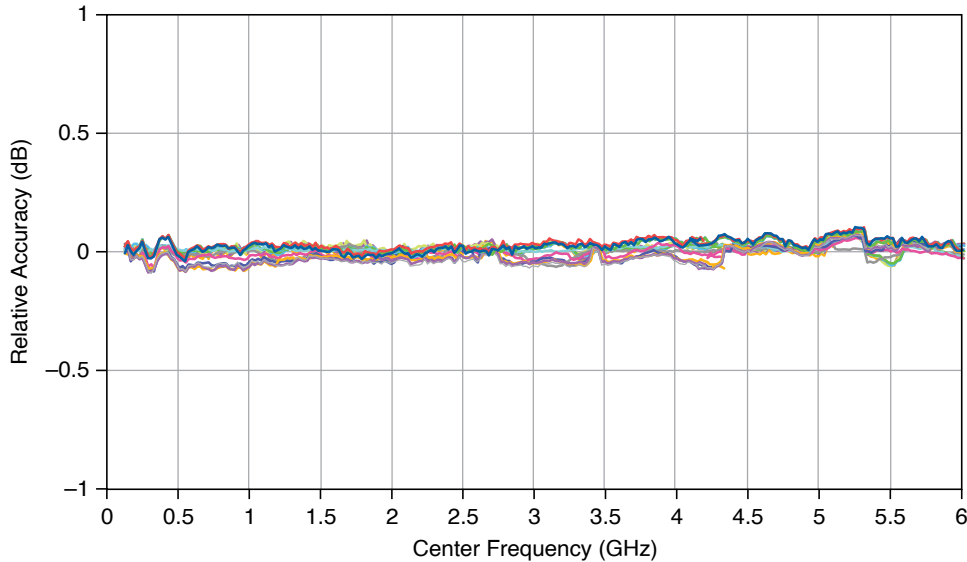
Conditions (10 MHz to <120 MHz): Reference level -30 dBm to +15 dBm; measured at the configured frequency; measurement performed after the PXIe-5841 has settled. Measured with a sine tone between -25 dBr to -5 dBr, where dBr is referenced to the configured RF reference level.

Conditions (120 MHz to 6 GHz): Reference level -30 dBm to +30 dBm; measured at 3.75 MHz offset from the configured center frequency when NI-RFSA Downconverter Frequency Offset Mode is User-Defined; measured at the configured center frequency when the NI-RFSA Downconverter Frequency Offset Mode is Enabled; measurement performed after the PXIe-5841 has settled. Preamplifier mode set to automatic. Measured with a sine tone within -25 dBr to -5 dBr, where dBr is referenced to the configured RF reference level.

Center frequency refers to NI-RFSA Downconverter Center Frequency when NI-RFSA Downconverter Frequency Offset Mode is User-Defined. Center frequency refers to NI-RFSA I/Q Carrier Frequency when NI-RFSA Downconverter Frequency Offset Mode is Enabled.

Figure 3. Input Relative Accuracy, 120 MHz to 6 GHz, -65 dBm to +30 dBm, Normalized to 0 dBm

Reference Level, Measured



RF Input Absolute Amplitude Accuracy

Table 14. Input Absolute Amplitude Accuracy (dB)

Center Frequency	Typical	Specification 0 °C to 55 °C Self-Cal °C ± 5 °C
10 MHz to <120 MHz	±0.35	—
120 MHz to 2.2 GHz	±0.25	±0.7
>2.2 GHz to 4.4 GHz	±0.25	±0.65
>4.4 GHz to 5 GHz	±0.25	±0.7
>5 GHz to 6 GHz	±0.25	±0.75

Conditions (10 MHz to <120 MHz): Reference level -30 dBm to +15 dBm; measured at the configured frequency; measurement performed after the PXIe-5841 has settled.

Conditions (120 MHz to 6 GHz): Reference level -30 dBm to +30 dBm; measured at 3.75 MHz offset from the configured center frequency when NI-RFSA Downconverter Frequency Offset Mode is User-Defined and measured at the configured center frequency when NI-RFSA Downconverter Frequency Offset Mode is Enabled; measurement performed after the PXIe-5841 has settled. Preamplifier mode set to automatic.

Center frequency refers to NI-RFSA Downconverter Center Frequency when NI-RFSA Downconverter Frequency Offset Mode is User-Defined. Center frequency refers to NI-RFSA I/Q Carrier Frequency when NI-RFSA Downconverter Frequency Offset Mode is Enabled.

RF Input Frequency Response

Table 15. Input Frequency Response (dB), Equalized (Offset Mode is User-Defined)

Downconverter Center Frequency	NI-RFSA Device Instantaneous Bandwidth	Frequency Response (dB)
≥250 MHz to 410 MHz	50 MHz	±0.45
		±0.35, typical
>410 MHz to 650 MHz	100 MHz	±0.6
		±0.45, typical
>650 MHz to 1.5 GHz	200 MHz	±0.55
		±0.4, typical
>1.5 GHz to 2.2 GHz	200 MHz	±0.5
		±0.35, typical
>2.2 GHz to 2.9 GHz	200 MHz	±0.5
		±0.3, typical
	1 GHz	±1.1
		±0.75, typical
>2.9 GHz to 4.8 GHz	200 MHz	±0.5
		±0.35, typical
	1 GHz	±1.15
		±0.75, typical
>4.8 GHz to 6 GHz	200 MHz	±0.5
		±0.35, typical
	1 GHz	±1.3
		±0.85, typical

Conditions: Reference level -30 dBm to +30 dBm; module temperature within ± 5 °C of last self-calibration temperature.

Frequency response is defined as the maximum relative amplitude deviation from the reference

Downconverter Center Frequency	NI-RFSA Device Instantaneous Bandwidth	Frequency Response (dB)
offset frequency. For the PXIe-5841 RF input, the reference offset frequency is 3.75 MHz. For the absolute amplitude accuracy at the reference offset, refer to the RF Input Absolute Amplitude Accuracy section.		

Figure 4. Measured 200 MHz Input Frequency Response, 0 dBm Reference Level, Normalized to 3.75 MHz

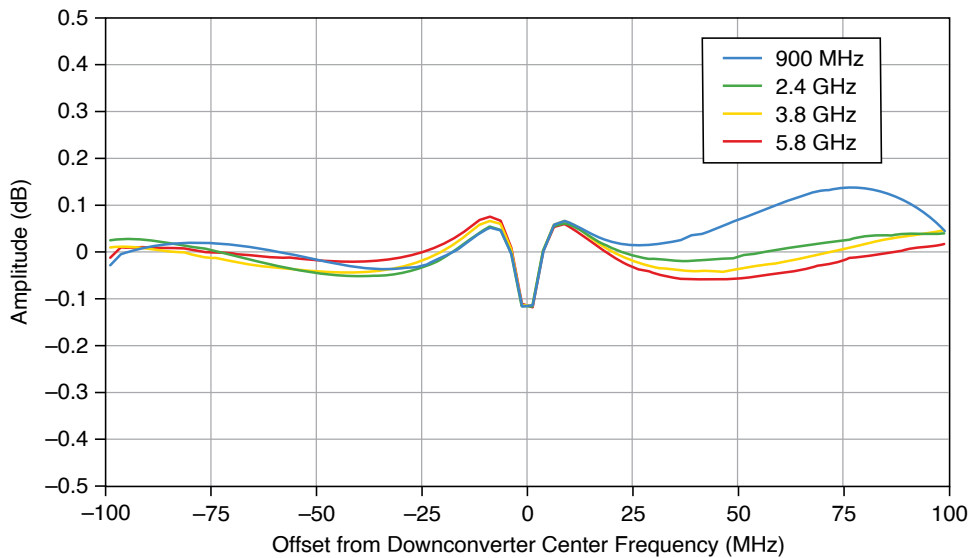


Figure 5. Measured 1 GHz Input Frequency Response, 0 dBm Reference Level, Normalized to 3.75 MHz

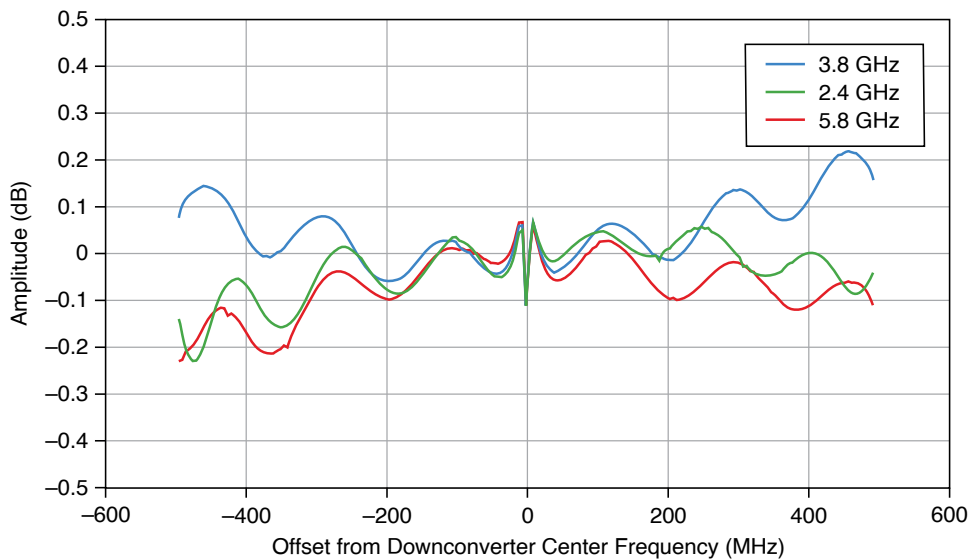


Table 16. Input Frequency Response (dB), Equalized (Offset Mode is Enabled)

I/Q Carrier Frequency	NI-RFSA Signal Bandwidth	Frequency Response (dB)
≥250 MHz to 378 MHz	10 MHz	±0.35
		±0.2, typical
>378 MHz to 593 MHz	35 MHz	±0.35
		±0.25, typical
>593 MHz to 1.168 GHz	85 MHz	±0.5
		±0.35, typical
>1.168 GHz to 1.943 GHz	235 MHz	±0.6
		±0.4, typical
>1.943 GHz to 6 GHz	235 MHz	±0.6
		±0.4, typical
	485 MHz	±1.05
		±0.7, typical

Conditions: Reference level -30 dBm to +30 dBm; module temperature within ± 5 °C of last self-calibration temperature.



Note For the 200 MHz Bandwidth Option, NI-RFSA Signal Bandwidth is limited to a maximum of 200 MHz.

Frequency response is defined as the maximum relative amplitude deviation from the specified I/Q carrier frequency. For the absolute amplitude accuracy at the I/Q carrier frequency, refer to the [RF Input Absolute Amplitude Accuracy](#) section.

Figure 6. Measured 235 MHz Input Frequency Response, 0 dBm Reference Level, Normalized to I/Q

Carrier Frequency (Offset Mode is Enabled)

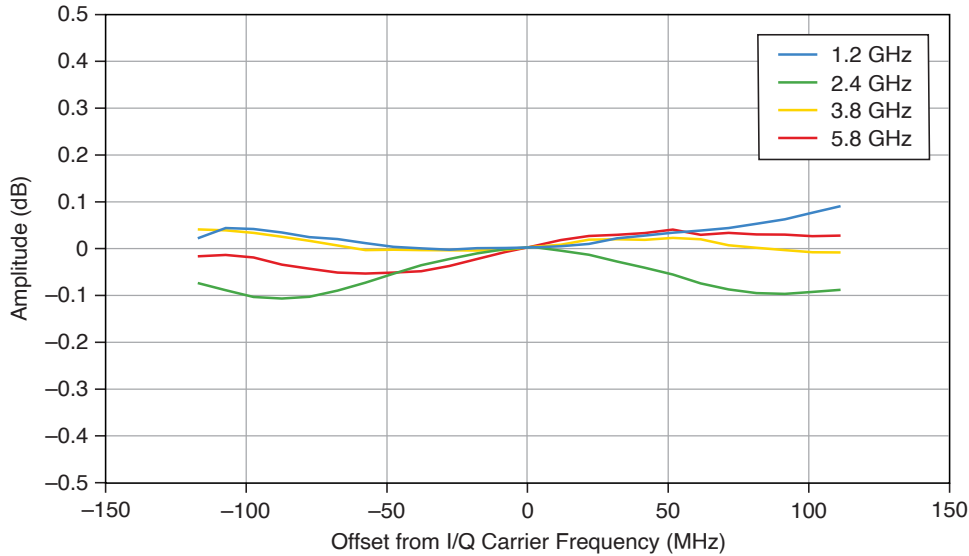
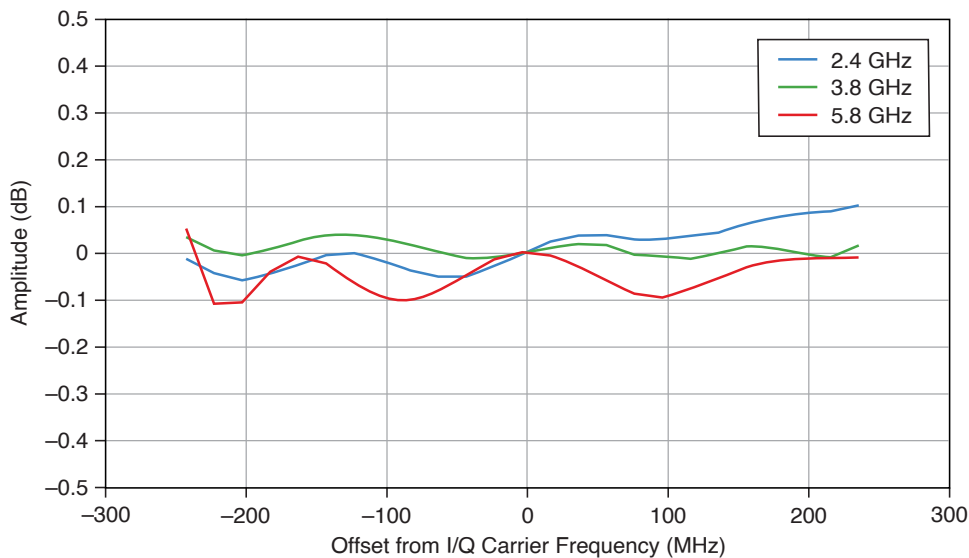


Figure 7. Measured 485 MHz Input Frequency Response, 0 dBm Reference Level, Normalized to I/Q Carrier Frequency (Offset Mode is Enabled)



RF Input Average Noise Density

Table 17. Input Average Noise Density (dBm/Hz), Typical

Downconverter Center Frequency	-50 dBm Reference Level	-10 dBm Reference Level	-5 dBm Reference Level
>120 MHz to 410 MHz	-163	-152	-148
>410 MHz to 2.7 GHz	-164	-151	-147
>2.7 GHz to 4.5 GHz	-164	-149	-145
>4.5 GHz to 6.0 GHz	-162	-149	-145

Downconverter Center Frequency	-50 dBm Reference Level	-10 dBm Reference Level	-5 dBm Reference Level
Conditions: Input terminated with a 50 Ω load; 50 averages; noise measured at 4 MHz offset, normalized to 1 Hz bandwidth. The -50 dBm reference level configuration has the preamplifier enabled. The -10 dBm and -5 dBm reference level configurations have the preamplifier disabled.			

RF Input Spurious Responses

RF Input Third-Order Input Intermodulation

Table 18. Third-Order Input Intercept Point (IIP₃, dBm), Typical

Downconverter Center Frequency	-5 dBm Reference Level	-20 dBm Reference Level (Preamp Disabled)	-20 dBm Reference Level (Preamp Enabled)
120 MHz to 410 MHz	20	9	4
>410 MHz to 1.3 GHz	21	9	9
>1.3 GHz to 2.7 GHz	22	9	7
>2.7 GHz to 4.5 GHz	21	9	7
>4.5 GHz to 6.0 GHz	16	3	0
Conditions: Two tones at offsets of 10 MHz and 10.7 MHz. Tone powers are -10 dBm and -25 dBm for -5 dBm and -20 dBm reference levels, respectively.			

RF Input Nonharmonic Spurs

Table 19. Input Nonharmonic Spurs (dBc), Typical

Downconverter Center Frequency	10 kHz \leq Offset < 100 kHz		100 kHz \leq Offset < 1 MHz		1 MHz \leq Offset	
	PXIe-5841	PXIe-5655	PXIe-5841	PXIe-5655	PXIe-5841	PXIe-5655
>120 MHz to 650 MHz	-71	-77	-74	-77	-68	-77

Downconverter Center Frequency	10 kHz ≤ Offset < 100 kHz		100 kHz ≤ Offset < 1 MHz		1 MHz ≤ Offset	
	PXIe-5841	PXIe-5655	PXIe-5841	PXIe-5655	PXIe-5841	PXIe-5655
>650 MHz to 1.3 GHz	-71	-77	-72	-77	-73	-77
>1.3 GHz to 2.7 GHz	-69	-76	-70	-78	-74	-71
>2.7 GHz to 4.5 GHz	-66	-76	-64	-73	-67	-69
>4.5 GHz to 6 GHz	-62	-75	-62	-73	-63	-66

Conditions: Reference level 0 dBm. Preamplifier disabled. Measured with a single tone, -6 dBr, where dBr is referenced to the configured RF reference level. LO set to integer mode for downconverter center frequency ≤500 MHz.

Offset refers to \pm desired signal offset (Hz) around the current downconverter center frequency.

(1 MHz ≤ offset): the maximum offset is limited to within the equalized bandwidth of the referenced LO frequency.

RF Input LO Residual Power

Table 20. Input LO Residual Power (dBr), Typical

Downconverter Center Frequency	Reference Level	
	-30 dBm to <-20 dBm	-20 dBm to +30 dBm
≥120 MHz to 650 MHz	-50	-53
>650 MHz to 1.3 GHz	-53	-61
>1.3 GHz to 2.7 GHz	-57	-61
>2.7 GHz to 4.5 GHz	-45	-53
>4.5 GHz to 6 GHz	-48	-51

Maximum residual LO power across full device bandwidth using the internal LO of the PXIe-5841. Input tone power at a maximum of -6 dBr. Measurement performed immediately after device self-calibration.

Downconverter Center Frequency	Reference Level	
	-30 dBm to <-20 dBm	-20 dBm to +30 dBm
<p>The PXIe-5841 uses the low frequency subsystem to directly acquire the RF input signal below 120 MHz.</p> <p>Here dB_r is relative to the full scale of the configured RF reference level.</p>		

Figure 8. Input LO Residual Power, Measured (PXIe-5841)

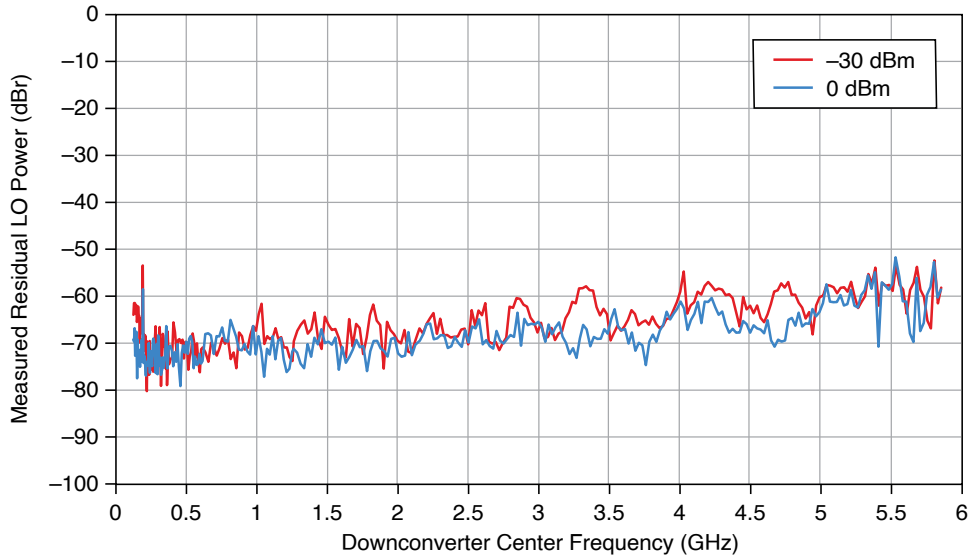
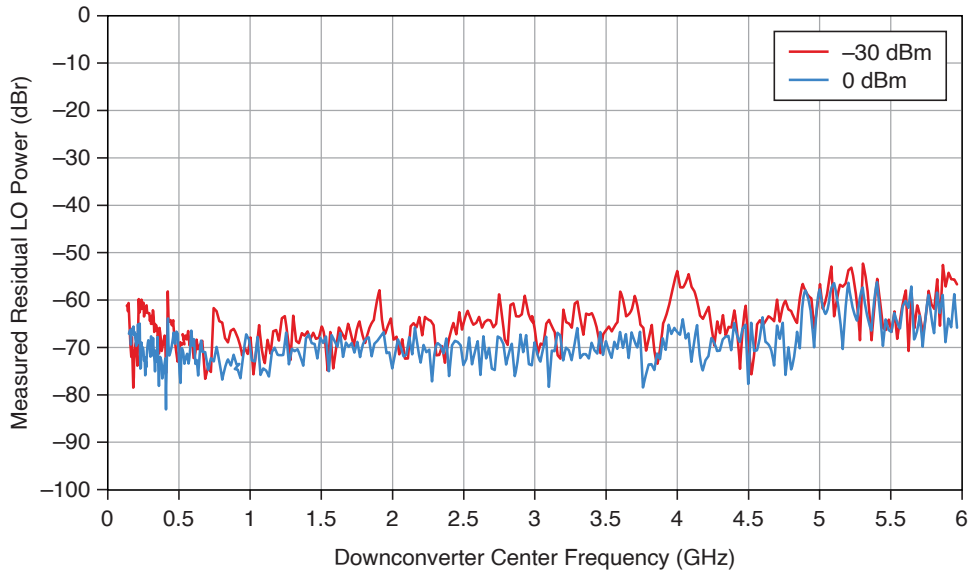


Figure 9. Input LO Residual Power, Measured (PXIe-5841 with PXIe-5655)



RF Input Residual Sideband Image

Table 21. Input Residual Sideband Image (dBc), Typical

Downconverter Center Frequency	NI-RFSA Device Instantaneous Bandwidth Setting	Input Bandwidth	Residual Sideband Image (dBc)
≥120 MHz to 410 MHz	50 MHz	50 MHz	-55
>410 MHz to 650 MHz	100 MHz	100 MHz	-55
>650 MHz to 1.3 GHz	200 MHz	200 MHz	-60
>1.3 GHz to 2.2 GHz	500 MHz	200 MHz	-57
		500 MHz	-54
>2.2 GHz to 2.7 GHz	1 GHz	200 MHz	-60
		500 MHz	-55
		1 GHz	-49
>2.7 GHz to 5.2 GHz	1 GHz	200 MHz	-57
		500 MHz	-56
		1 GHz	-53
>5.2 GHz to 6 GHz	1 GHz	200 MHz	-55
		500 MHz	-53
		1 GHz	-49

Conditions: Reference levels -30 dBm to +30 dBm.



Note For the 200 MHz Bandwidth Option, NI-RFSA Device Instantaneous Bandwidth is limited to a maximum of 200 MHz.

The PXIe-5841 uses the low frequency subsystem to directly acquire the RF signal below 120 MHz.

This specification describes the maximum residual sideband image within the device bandwidth centered around a given RF center frequency. Measurement performed immediately after device self-calibration.

The input bandwidth describes the occupied bandwidth of the input signal centered at the downconverter center frequency.

Figure 10. Input Residual Sideband Image, 0 dBm Reference Level, Measured

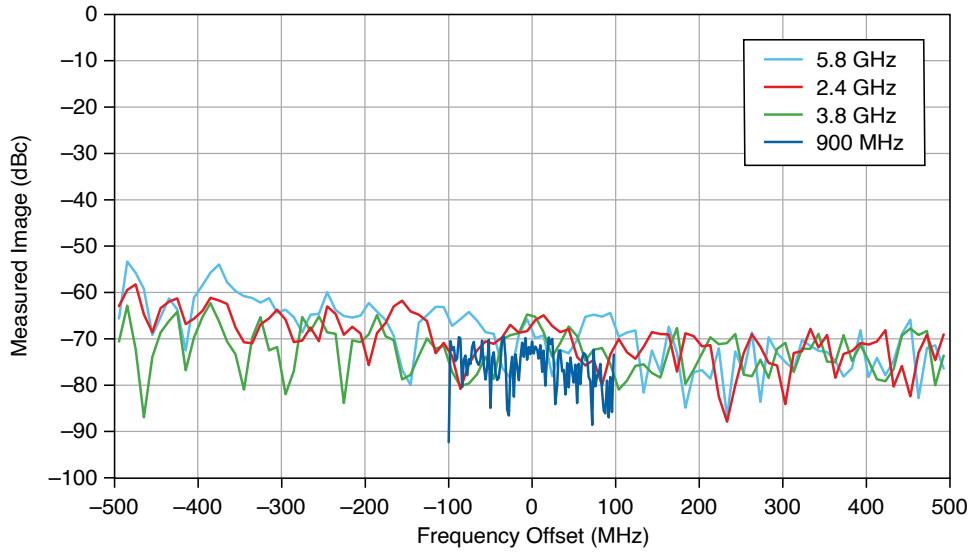
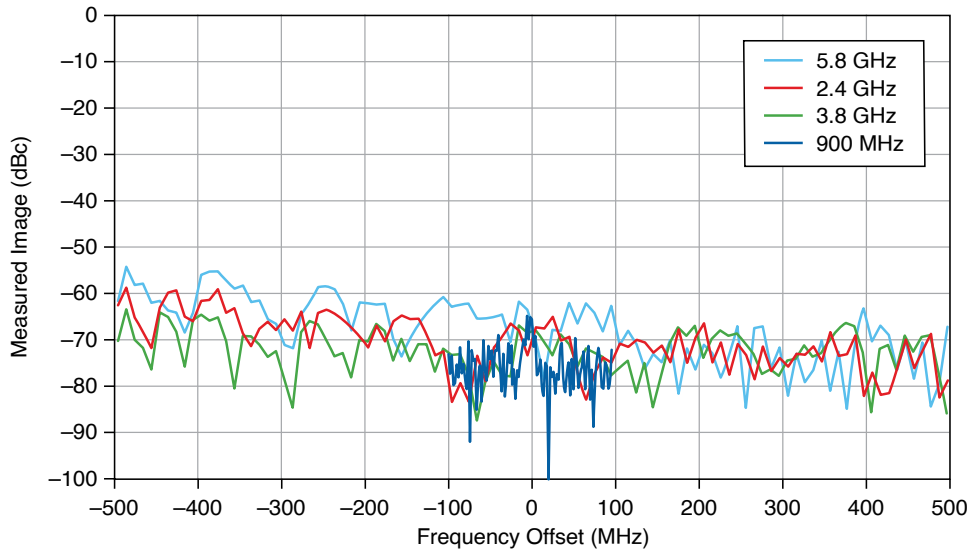


Figure 11. Input Residual Sideband Image, -30 dBm Reference Level, Measured



RF Output

RF Output Power Range

Table 22. Output Power Range

NI-RFSG Bandwidth Setting	Upconverter Center Frequency	Power Range, CW, Average Power	
		Specification	Nominal
<120 MHz	9 kHz to <120 MHz	Noise Floor to +5 dBm	Noise Floor to +8 dBm
≤200 MHz	120 MHz to 4 GHz	Noise Floor to +18 dBm	Noise Floor to ≥+20 dBm

NI-RFSG Bandwidth Setting	Upconverter Center Frequency	Power Range, CW, Average Power	
		Specification	Nominal
	>4 GHz to 6 GHz	Noise Floor to +15 dBm	Noise Floor to \geq +17 dBm
1 GHz	\geq 2.2 GHz to 4 GHz	Noise Floor to +18 dBm	Noise Floor to \geq +20 dBm
	>4 GHz to 6 GHz	Noise Floor to +10 dBm	Noise Floor to \geq +15 dBm

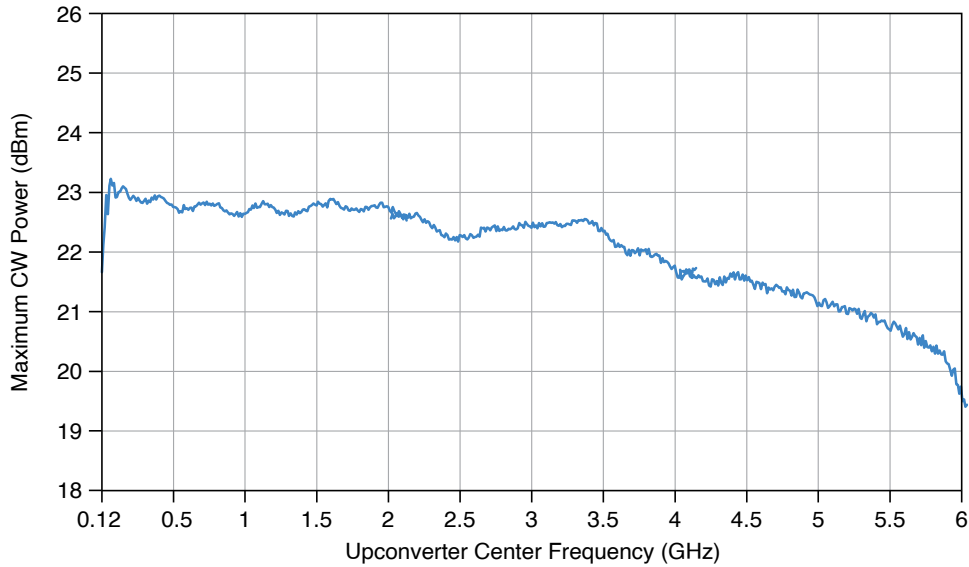


Note For the 200 MHz Bandwidth Option, NI-RFSG Bandwidth Setting is limited to a maximum of 200 MHz.

The power range refers to CW average power. For modulated signal generation, it is important to consider the impact of peak to average power ratio (PAPR). For example, a modulated 20 MHz signal between 120 MHz to 4 GHz with a 12 dB PAPR can be generated with up to +6 dBm (+8 dBm, nominal) average modulated power.

Output attenuator resolution	1 dB, nominal
Digital attenuation resolution (average output power \geq -100 dBm)	<0.1 dB

Figure 12. Output Maximum CW Average Power (dBm), Measured



RF Output Amplitude Settling Time

<0.5 dB of final value	60 μ s, typical
<0.1 dB of final value	85 μ s, typical

Conditions: varying RF output power range.

RF Output Power Level Accuracy

Table 23. Output Power Level Accuracy (dB)

Center Frequency	Typical	Specification 0 °C to 55 °C Self-Cal °C ± 5 °C
10 MHz to <120 MHz	± 0.35	—
>120 MHz to 200 MHz	± 0.25	± 0.8
>200 MHz to 500 MHz	± 0.25	± 0.7
>500 MHz to 2.2 GHz	± 0.25	± 0.65
>2.2 GHz to 6 GHz	± 0.25	± 0.7

Center Frequency	Typical	Specification 0 °C to 55 °C Self-Cal °C ± 5 °C
<p>Relative accuracy describes the residual absolute accuracy error when compared to the absolute accuracy error at 0 dBm power level.</p> <p>Conditions (10 MHz to <120 MHz): Power level -30 dBm to +5 dBm; measured at the configured frequency. Measurement performed after the PXIe-5841 has settled.</p> <p>Conditions (120 MHz to 6 GHz): Power level -30 dBm to +15 dBm; measured at 3.75 MHz offset from the configured center frequency when NI-RFSG Upconverter Frequency Offset Mode is User-Defined; measured at the configured center frequency when NI-RFSG Upconverter Frequency Offset Mode is Enabled. Measurement performed after the PXIe-5841 has settled.</p> <p>This specification is valid only when the module is operating within the specified ambient temperature range and within ±5 °C from the last self-calibration temperature, as measured with the onboard temperature sensors.</p> <p>This specification requires that temperature correction is being performed. Temperature correction is applied automatically if NIRFSG_ATTR_AUTOMATIC_THERMAL_CORRECTION is enabled (default). Temperature correction is applied if necessary only when NI-RFSG settings are adjusted. If NIRFSG_ATTR_AUTOMATIC_THERMAL_CORRECTION is disabled, the niRFSG_PerformThermalCorrection must be explicitly called.</p> <p>Center frequency refers to NI-RFSG Upconverter Center Frequency when NI-RFSG Upconverter Frequency Offset Mode is User-Defined. Center frequency refers to NI-RFSG I/Q Carrier Frequency when NI-RFSG Upconverter Frequency Offset Mode is Enabled.</p>		

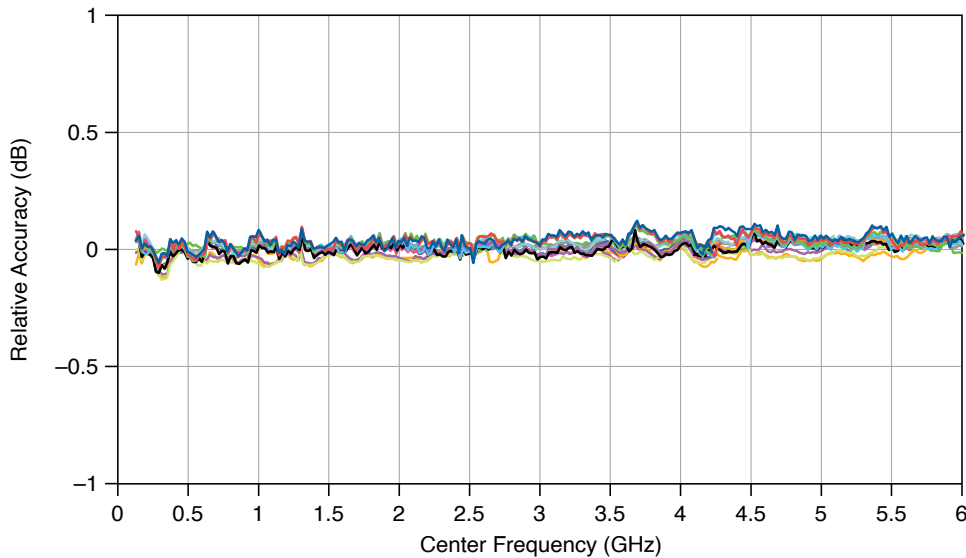
RF Output Relative Power Level Accuracy

Table 24. Output Relative Power Level Accuracy (dB)

Center Frequency	Typical
10 MHz to <120 MHz	±0.35
120 MHz to 6 GHz	±0.2
<p>Conditions (10 MHz to <120 MHz): Power level -30 dBm to +5 dBm; measured at the configured frequency. Measurement performed after the PXIe-5841 has settled.</p> <p>Conditions (120 MHz to 6 GHz): Power level -30 dBm to +15 dBm; measured at 3.75 MHz offset from</p>	

Center Frequency	Typical
<p>the configured center frequency when NI-RFSG Upconverter Frequency Offset Mode is User-Defined; measured at the configured center frequency when NI-RFSG Upconverter Frequency Offset Mode is Enabled. Measurement performed after the PXIe-5841 has settled.</p> <p>This specification requires that temperature correction is being performed. Temperature correction is applied automatically if NIRFSG_ATTR_AUTOMATIC_THERMAL_CORRECTION is enabled (default). Temperature correction is applied if necessary only when NI-RFSG settings are adjusted. If NIRFSG_ATTR_AUTOMATIC_THERMAL_CORRECTION is disabled, the niRFSG_PerformThermalCorrection must be explicitly called.</p> <p>Center frequency refers to NI-RFSG Upconverter Center Frequency when NI-RFSG Upconverter Frequency Offset Mode is User-Defined. Center frequency refers to I/Q Carrier Frequency when NI-RFSG Upconverter Frequency Offset Mode is Enabled.</p>	

Figure 13. Output Relative Power Accuracy, 120 MHz to 6 GHz, -65 dBm to +15 dBm, Normalized to 0 dBm Power Level, Measured



RF Output Frequency Response

Table 25. Output Frequency Response (dB), Equalized (Offset Mode is Disabled)

Upconverter Center Frequency	NI-RFSG Signal Bandwidth Setting	Frequency Response (dB)
≥250 MHz to 410 MHz	50 MHz	±0.55
		±0.45, typical

Upconverter Center Frequency	NI-RFSG Signal Bandwidth Setting	Frequency Response (dB)
>410 MHz to 650 MHz	100 MHz	±0.6
		±0.45, typical
>650 MHz to 1.5 GHz	200 MHz	±0.55
		±0.4, typical
>1.5 GHz to 2.2 GHz	200 MHz	±0.4
		±0.3, typical
>2.2 GHz to 2.9 GHz	200 MHz	±0.4
		±0.3, typical
	1 GHz	±1.2
		±0.8, typical
>2.9 GHz to 4.8 GHz	200 MHz	±0.6
		±0.45, typical
	1 GHz	±1.25
		±0.85, typical
>4.8 GHz to 6 GHz	200 MHz	±0.55
		±0.4, typical
	1 GHz	±1.9
		±1.35, typical

Conditions: Output peak power level -30 dBm to +15 dBm; module temperature within ±5 °C of last self-calibration temperature.

Frequency response is defined as the maximum relative amplitude deviation from the reference offset frequency. For the PXIe-5841 RF Output the reference offset frequency is 3.75 MHz. For the absolute amplitude accuracy at the reference offset, refer to the *RF Output Power Level Accuracy* section.

Figure 14. Measured 200 MHz Output Frequency Response, 0 dBm Output Power Level, Normalized to

3.75 MHz

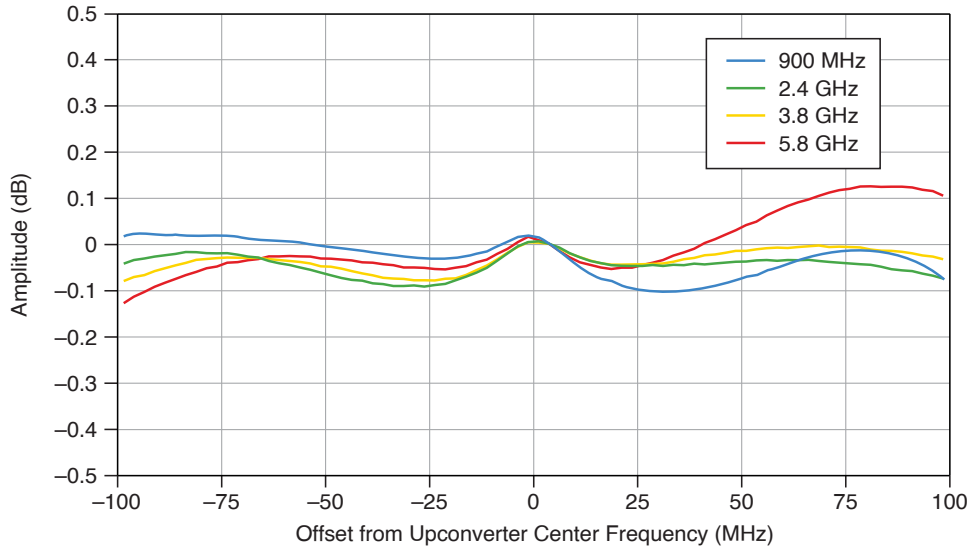


Figure 15. Measured 1 GHz Output Frequency Response, 0 dBm Output Power Level, Normalized to 3.75 MHz

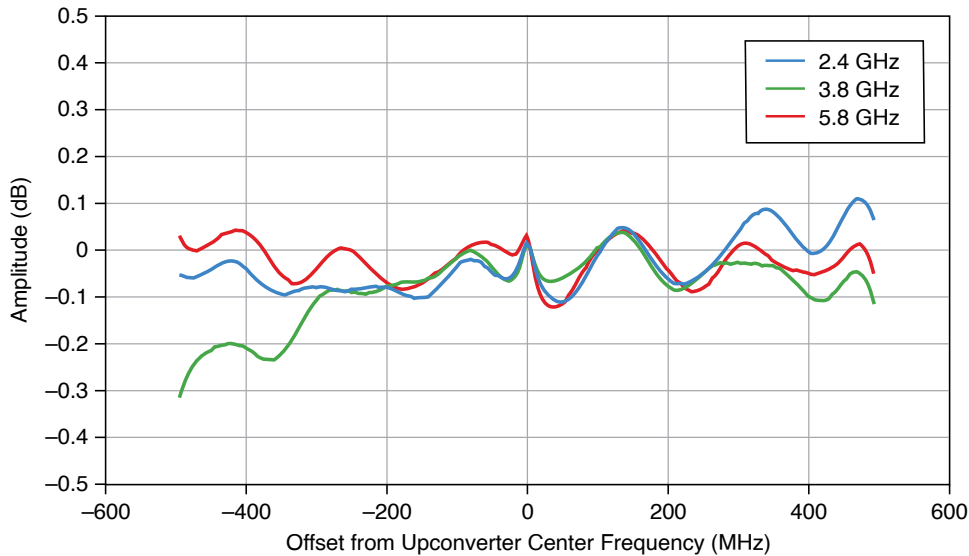



Table 26. Output Frequency Response (dB), Equalized (Offset Mode is Enabled)

I/Q Carrier Frequency	NI-RFSG Signal Bandwidth	Frequency Response (dB)
≥120 MHz to 378 MHz	10 MHz	±0.3
		±0.2, typical
>378 MHz to 593 MHz	35 MHz	±0.55
		±0.4, typical
>593 MHz to 1.168 GHz	85 MHz	±0.4
		±0.25, typical

I/Q Carrier Frequency	NI-RFSG Signal Bandwidth	Frequency Response (dB)
>1.168 GHz to 1.943 GHz	235 MHz	±0.5
		±0.45, typical
>1.943 GHz to 6 GHz	235 MHz	±0.65
		±0.45, typical
	485 MHz	±1.0
		±0.7, typical

Conditions: Output peak power level -30 dBm to +15 dBm; module temperature within ±5 °C of last self-calibration temperature.

 **Note** For the 200 MHz Bandwidth Option, NI-RFSG Signal Bandwidth is limited to a maximum of 200 MHz.

Frequency response is defined as the maximum relative amplitude deviation from the specified I/Q carrier frequency. For the absolute amplitude accuracy at the reference offset, refer to the *RF Output Power Level Accuracy* section.

Figure 16. Measured 200 MHz Output Frequency Response, 0 dBm Output Power Level, Normalized to I/Q Carrier Frequency (Offset Mode is Enabled)

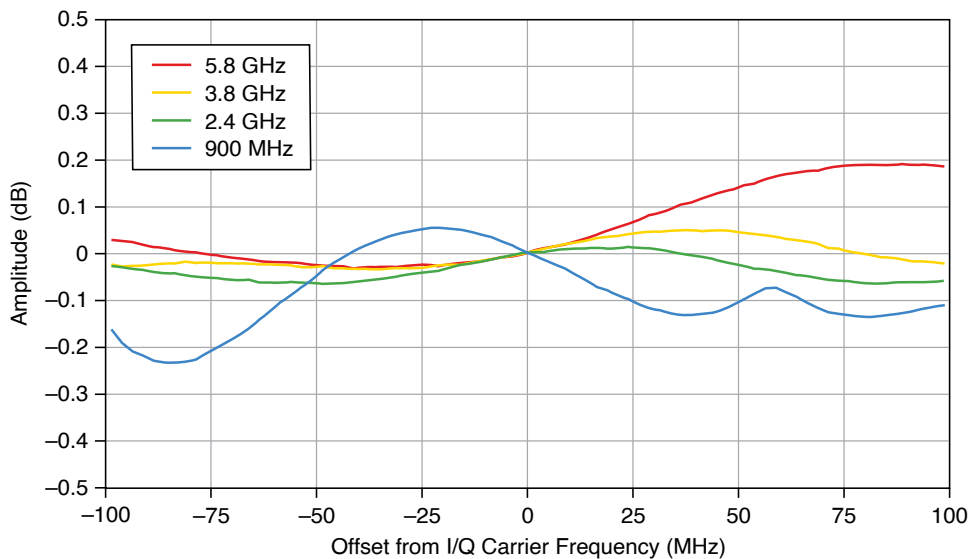
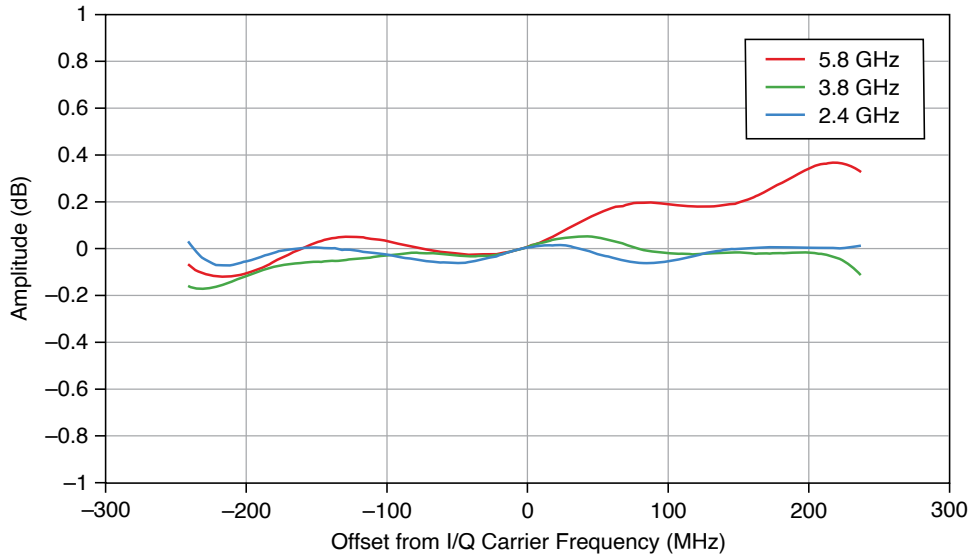


Figure 17. Measured 485 MHz Output Frequency Response, 0 dBm Output Power Level, Normalized to

I/Q Carrier Frequency (Offset Mode is Enabled)



RF Output Average Noise Density

Table 27. Output Average Noise Density (dBm/Hz), Typical

Upconverter Center Frequency	Output Power Level (Peak)		
	-30 dBm	0 dBm	10 dBm
10 MHz to <120 MHz	-151	-147	—
120 MHz to 410 MHz	-165	-140	-131
>410 MHz to 1.3 GHz	-165	-143	-134
>1.3 GHz to 2.7 GHz	-164	-142	-132
>2.7 GHz to 4.5 GHz	-162	-144	-134
>4.5 GHz to 6.0 GHz	-163	-139	-128

Conditions: 50 averages; -40 dB baseband signal attenuation; noise measurement frequency offset 4 MHz relative to output frequency.

RF Output Spurious Responses

RF Output Third-Order Intermodulation (IMD₃)

Table 28. IMD₃ (dBc), -6 dBm Tones, Typical

Upconverter Center Frequency	Baseband DAC: -2 dBFS Peak Power Level: 2 dBm	Baseband DAC: -6 dBFS Peak Power Level: 6 dBm
10 MHz to 120 MHz	-65	-70
>120 MHz to 410 MHz	-61	-67
>410 MHz to 1.3 GHz	-58	-66
>1.3 GHz to 2.7 GHz	-57	-68
>2.7 GHz to 4.5 GHz	-55	-64
>4.5 GHz to 6.0 GHz	-58	-63

Conditions: -6 dBm tones at 1.6 MHz and 2.3 MHz offset from the LO. Output power level set to achieve the desired output power per tone allowing specified digital headroom.

Table 29. IMD₃ (dBc), -36 dBm Tones, Typical

Upconverter Center Frequency	Baseband DAC: -2 dBFS Peak Power Level: -28 dBm	Baseband DAC: -6 dBFS Peak Power Level: -24 dBm
10 MHz to 120 MHz	-71	-72
>120 MHz to 410 MHz	-61	-65
>410 MHz to 1.3 GHz	-59	-65
>1.3 GHz to 2.7 GHz	-62	-69
>2.7 GHz to 4.5 GHz	-60	-70
>4.5 GHz to 6.0 GHz	-61	-68

Conditions: -36 dBm tones at 1.6 MHz and 2.3 MHz offset from the LO. Output power level set to achieve the desired output power per tone allowing specified digital headroom.

RF Output Harmonics

Table 30. Output Second Harmonic Level (dBc), Typical

Upconverter Center Frequency	CW Average Power		
	-10 dBm	6 dBm	15 dBm
10 MHz to 120 MHz	-63	-45	—
>120 MHz to 410 MHz	-52	-39	-31
>410 MHz to 1.3 GHz	-49	-41	-35
>1.3 GHz to 2.7 GHz	-45	-40	-34
>2.7 GHz to 4.5 GHz	-45	-40	-34
>4.5 GHz to 6 GHz	-47	-44	-33

Conditions: Measured using a -1 dBFS baseband signal with 1 MHz offset.

RF Output Nonharmonic Spurs

Table 31. Output Nonharmonic Spurs (dBc), Typical

Upconverter Center Frequency	10 kHz ≤ Offset < 100 kHz		100 kHz ≤ Offset < 1 MHz		1 MHz ≤ Offset	
	PXle-5841	PXle-5655	PXle-5841	PXle-5655	PXle-5841	PXle-5655
120 MHz to 650 MHz (LO PLL Fractional Mode disabled.)	-82	-95	-77	-78	-65	-72
>650 MHz to 1.3 GHz	-83	-97	-75	-74	-71	-73
>1.3 GHz to 2.2 GHz	-78	-95	-74	-76	-72	-74
>2.2 GHz to 4.5 GHz	-72	-89	-68	-89	-66	-66
>4.5 GHz to 6 GHz	-73	-86	-68	-89	-67	-65

Upconverter Center Frequency	10 kHz ≤ Offset < 100 kHz		100 kHz ≤ Offset < 1 MHz		1 MHz ≤ Offset	
	PXle-5841	PXle-5655	PXle-5841	PXle-5655	PXle-5841	PXle-5655
<p>Conditions: Output full scale 0 dBm. Measured with a single tone at 0 dBFS.</p> <p>Offset refers to \pmdesired signal offset (Hz) around the current LO frequency.</p> <p>The maximum offset is limited to within the equalized bandwidth of the referenced LO Frequency.</p>						

RF Output LO Residual Power

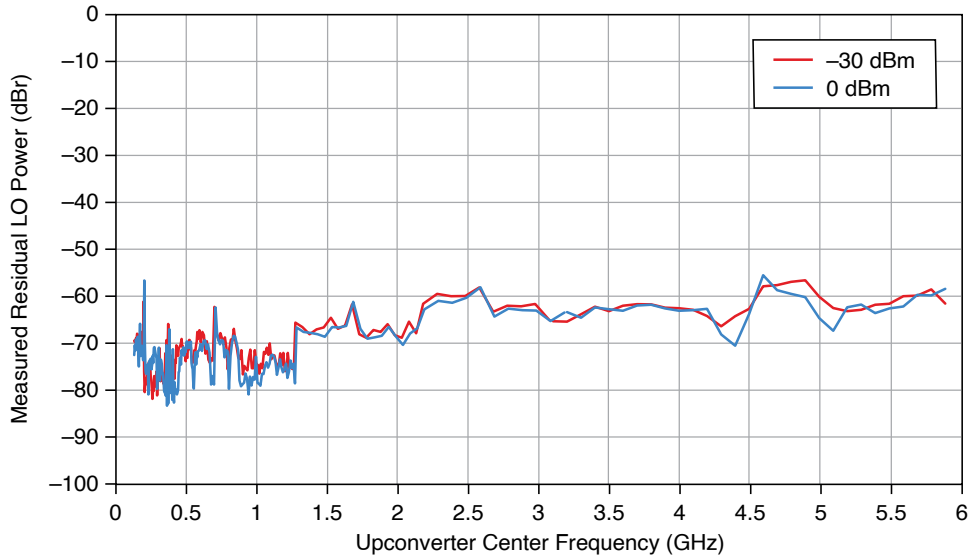
Table 32. Output LO Residual Power (dBr, Typical)

Upconverter Center Frequency	LO Residual Power
≥120 MHz to 650 MHz	-55
>650 MHz to 2.2 GHz	-60
>2.2 GHz to 4.5 GHz	-57
>4.5 GHz to 6 GHz	-51

Conditions: Maximum residual LO power across full device bandwidth using the internal LO of the PXle-5841. Peak output power -30 dBm to +15 dBm, tone at -6 dBFS. Measurement performed immediately after device self-calibration.

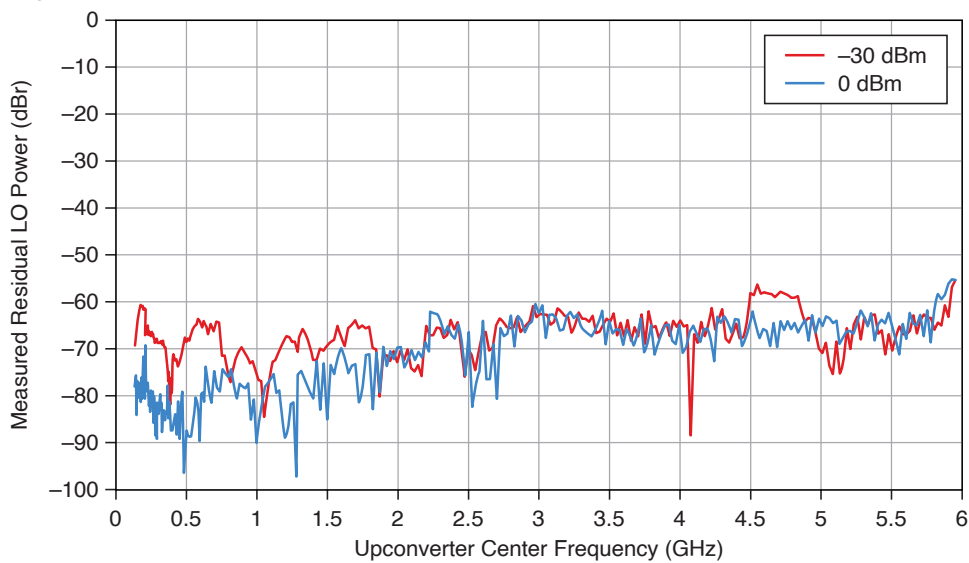
The PXle-5841 uses the low frequency subsystem to directly generate the RF signal below 120 MHz.

Figure 18. Output LO Residual Power, Measured (PXIe-5841)



Conditions: LO is not exported; degradation when LO export is enabled.

Figure 19. Output LO Residual Power, Measured (PXIe-5841 with PXIe-5655)



RF Output Residual Sideband Image

Table 33. Output Residual Sideband Image (dBc), Typical

Upconverter Center Frequency	NI-RFSG Signal Bandwidth Setting	Output Bandwidth	Residual Sideband Image
≥120 MHz to 410 MHz	50 MHz	50 MHz	-46
>410 MHz to 650 MHz	100 MHz	100 MHz	-62

Upconverter Center Frequency	NI-RFSG Signal Bandwidth Setting	Output Bandwidth	Residual Sideband Image
>650 MHz to 1.3 GHz	200 MHz	200 MHz	-60
>1.3 GHz to 2.2 GHz	200 MHz	200 MHz	-65
	500 MHz	500 MHz	-63
>2.2 GHz to 4.5 GHz	200 MHz	200 MHz	-63
	500 MHz	500 MHz	-58
	1 GHz	1 GHz	-53
>4.5 GHz to 6 GHz	200 MHz	200 MHz	-57
	500 MHz	500 MHz	-52
	1 GHz	1 GHz	-43

Conditions: Reference levels -30 dBm to +15 dBm.



Note For the 200 MHz Bandwidth Option, NI-RFSG Signal Bandwidth Setting is limited to a maximum of 200 MHz.

The PXIe-5841 uses the low frequency subsystem to directly acquire the RF input signal below 120 MHz.

This specification describes the maximum residual sideband image within the device bandwidth centered around a given RF center frequency. Measurement performed immediately after device self-calibration.

Figure 20. Output Residual Sideband Image, 0 dBm Average Output Power, Measured

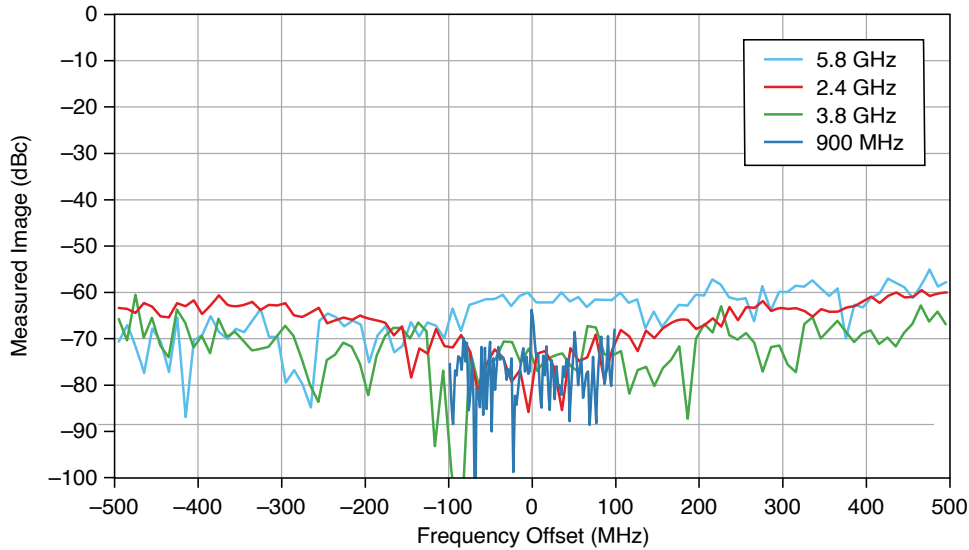
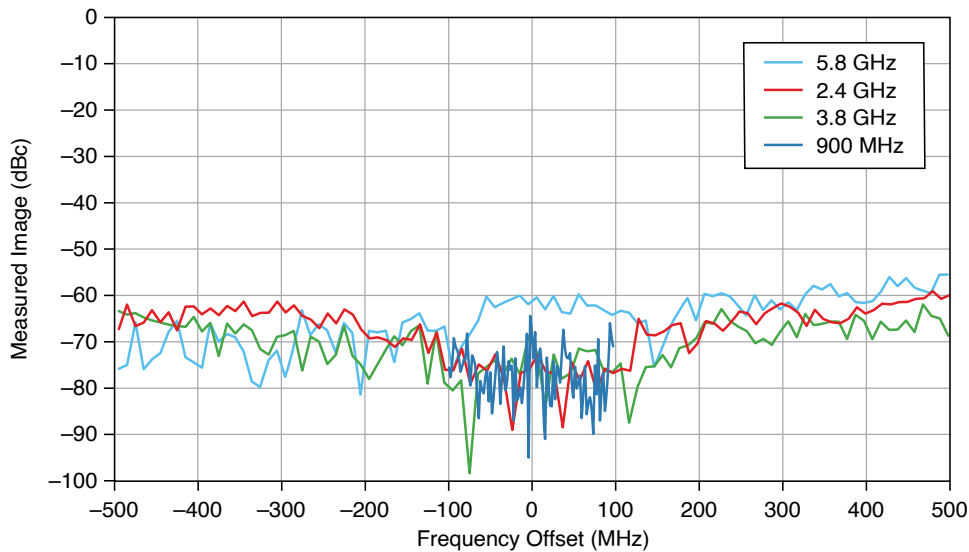


Figure 21. Output Residual Sideband Image, -30 dBm Average Output Power, Measured



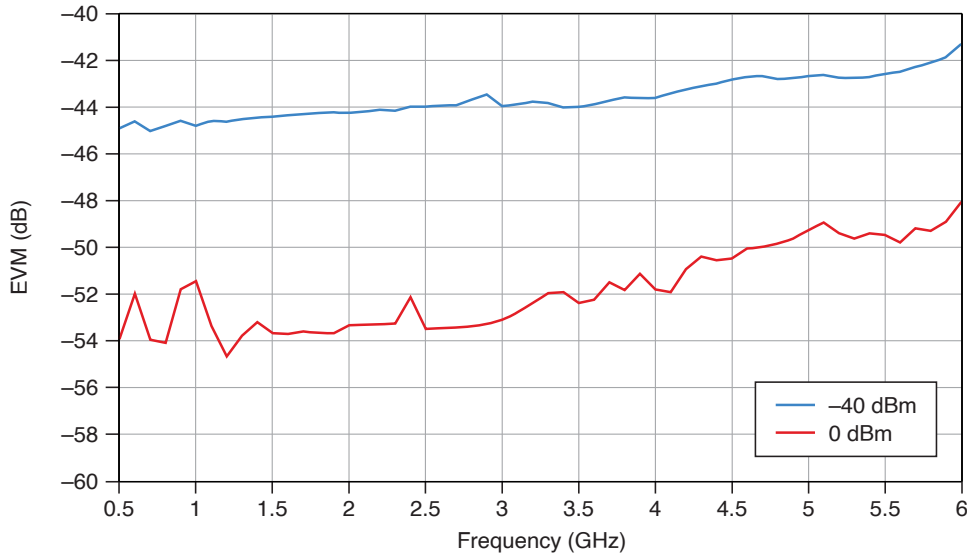
Error Vector Magnitude (EVM)

Table 34. Loopback EVM, RMS (dB), typical

I/Q carrier frequency	400 MHz to <4 GHz	-48
	5 GHz to 6 GHz	-47

Conditions: Modulated signal with 20 MHz bandwidth 64-QAM modulated signal; Pulse-shape filtering: root-raised cosine, alpha=0.25; RF input reference level: 0 dBm; PXle-5841; Offset Mode: Enabled; PXle-5841 RF output peak power level: 0 dBm; Reference Clock source: Onboard; Acquisition length: 300 μ s

Figure 22. Measured RMS EVM

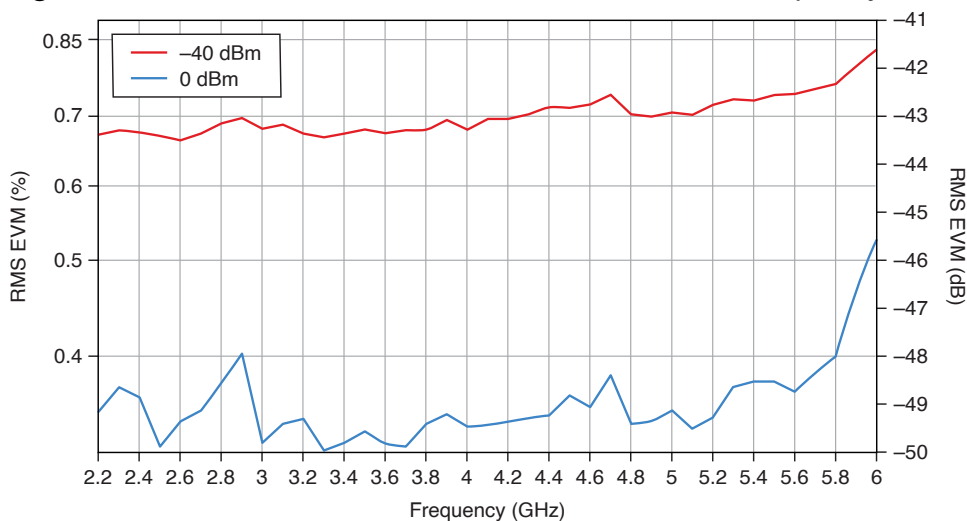


Conditions: 20 MHz bandwidth 64-QAM modulated signal. Pulse-shape filtering: Root-raised cosine, alpha=0.25; PXIe-5841 RF Input reference level, RF output peak power level set to value specified in legend; Offset Mode: Enabled; Reference Clock source: Onboard; Acquisition length: 300 μ s

Application-Specific Modulation Quality (PXIe-5841 with PXIe-5655)

5G NR

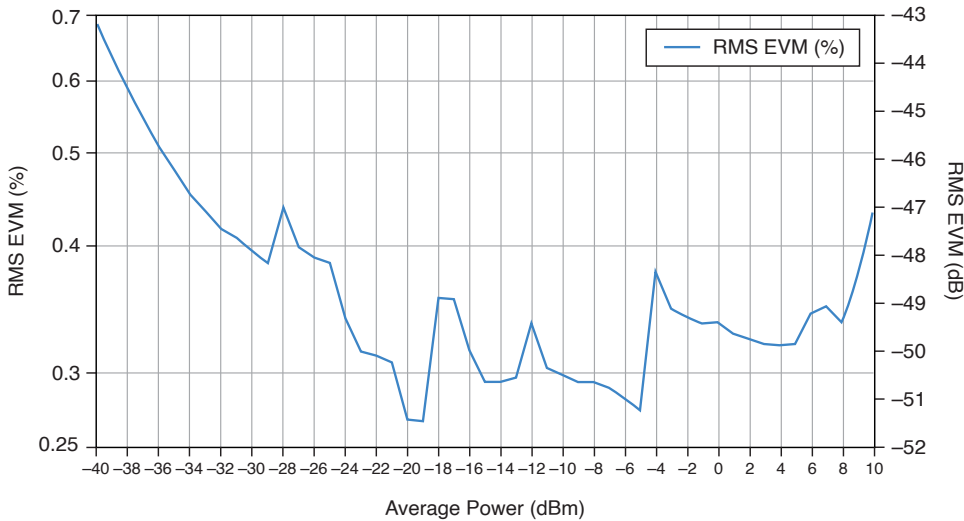
Figure 23. 5G NR Measured RMS EVM (dB and %) Versus Frequency (Hz)



Conditions: RF output loopback to RF input; Waveform bandwidth: 100 MHz;

Subcarrier spacing: 30 kHz, uplink, 256 QAM; Offset Mode: Enabled; Reference Level Headroom: Default (1 dB); Measurement length: 3 slots

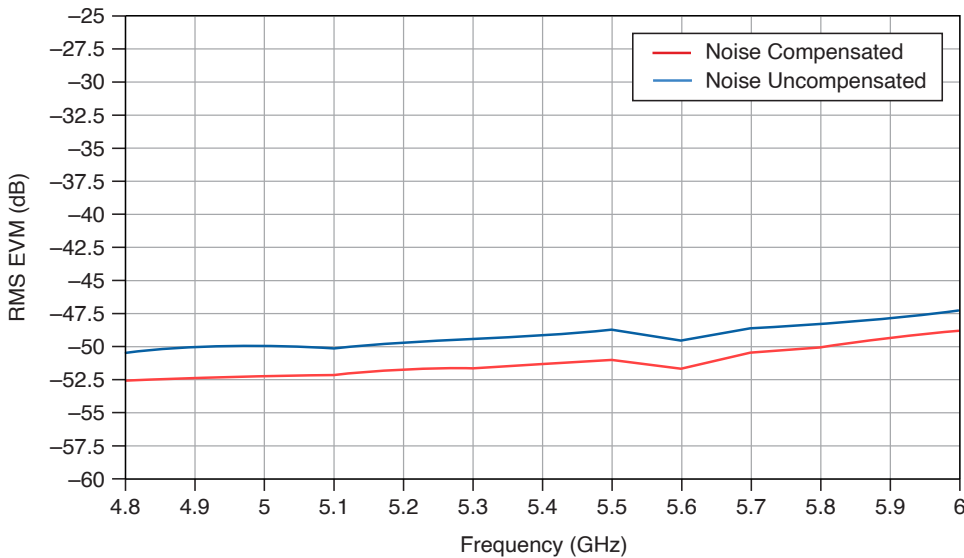
Figure 24. 5G NR Measured RMS EVM (dB and %) Versus Measured Average Power (dBm)



Conditions: RF output loopback to RF input; Reference/power level: average power +PAPR; Waveform bandwidth: 100 MHz; Subcarrier spacing: 30 kHz, uplink, 256 QAM; Offset Mode: Enabled; Reference Level Headroom: Default (1 dB); Measurement length : 3 slots

WLAN 802.11ax

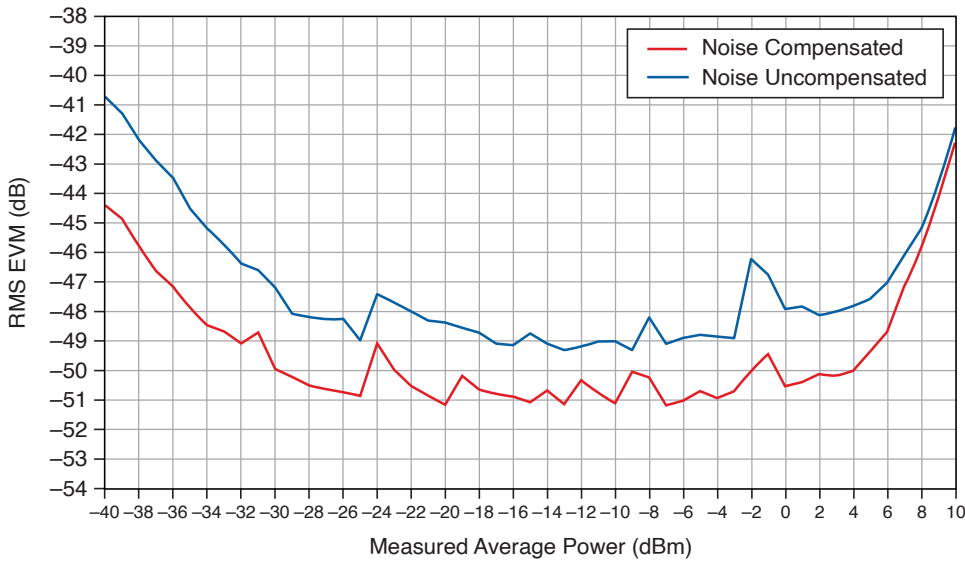
Figure 25. WLAN 802.11ax Measured RMS EVM (dB) Versus Frequency (Hz)



Conditions: RF output loopback to RF input; Waveform bandwidth: 80 MHz; MCS index:

11; Offset Mode: Enabled; RF output average power: -15 dBm; Reference level: average power + PAPR

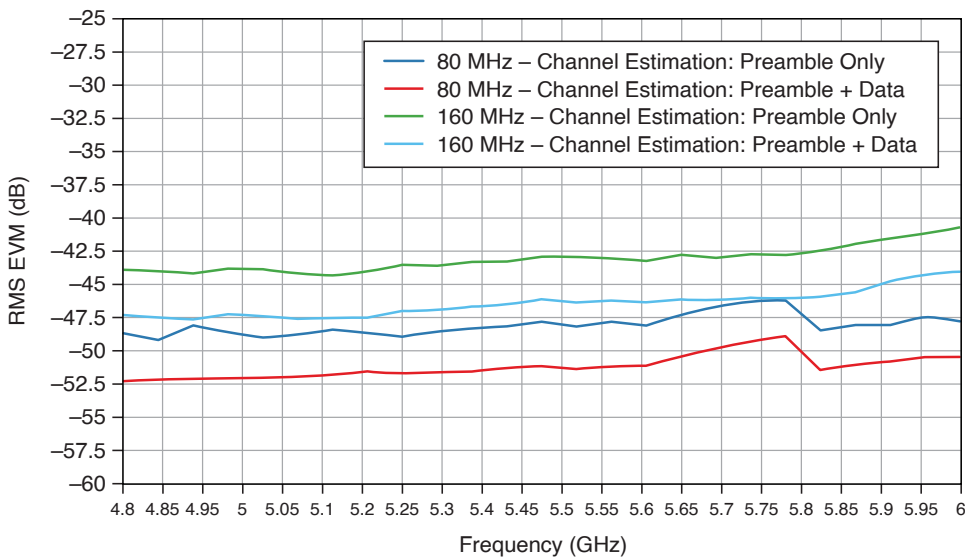
Figure 26. WLAN 802.11ax Measured RMS EVM (dB) Versus Measured Average Power (dBm)



Conditions: RF output loopback to RF input; Waveform bandwidth: 80 MHz; MCS index: 11; Offset Mode: Enabled; Carrier frequency: 5.5 GHz

WLAN 802.11ac

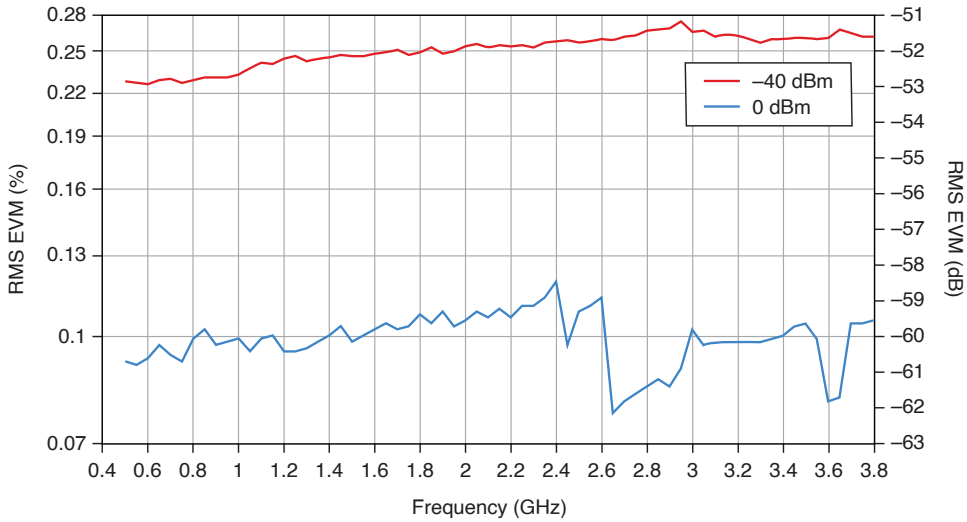
Figure 27. WLAN 802.11ac Measured RMS EVM (dB) Versus Frequency (Hz)



Conditions: RF output loopback to RF input; Offset Mode: Enabled; MCS index: 9; RF output average power: 0 dBm; Reference level: average power + PAPR; Internal LO

LTE

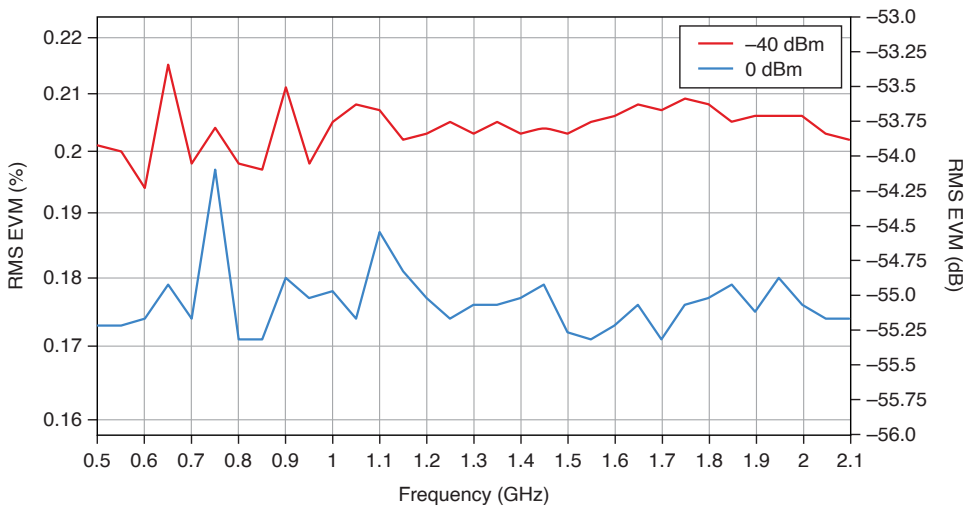
Figure 28. LTE Measured RMS EVM (dB and %) Versus Frequency (Hz)



Conditions: RF Output loopback to RF Input; Offset Mode: Enabled; Independent onboard LOs; 20 MHz BW, Uplink, FDD; Average power + PAPR

WCDMA

Figure 29. WCDMA Measured RMS EVM (dB and %) Versus Frequency (Hz)

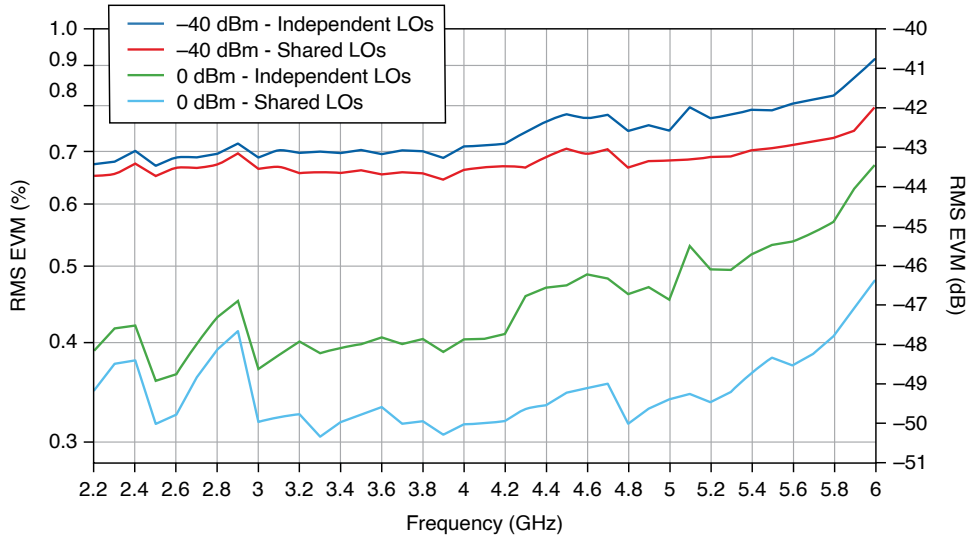


Conditions: RF output loopback to RF input; Offset Mode: Enabled; Independent onboard LOs.

Application-Specific Modulation Quality (PXle-5841)

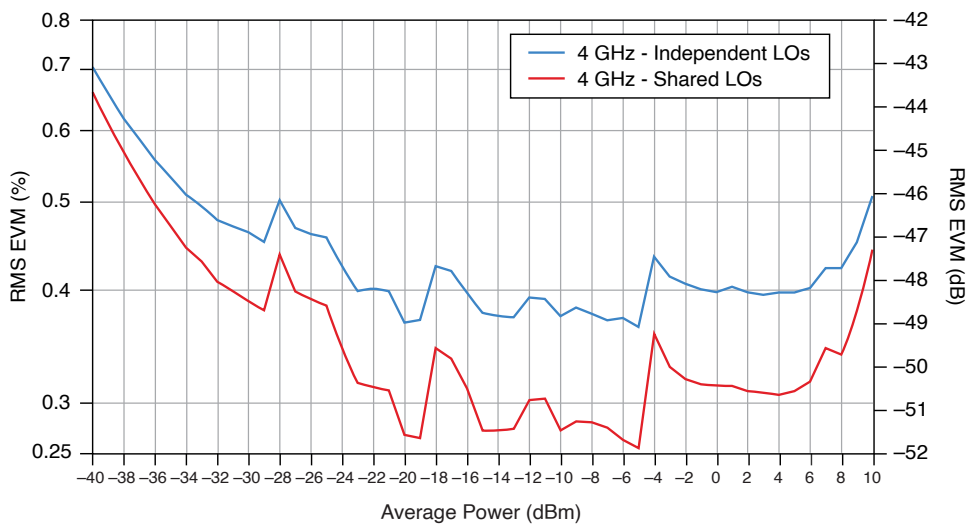
5G NR

Figure 30. 5G NR Measured RMS EVM (dB and %) Versus Frequency (Hz)



Conditions: RF output loopback to RF input; Waveform bandwidth: 100 MHz; Subcarrier spacing: 30 kHz, uplink, 256 QAM; Offset Mode: Enabled; Reference Level Headroom: Default (1 dB); Measurement length: 3 slots

Figure 31. 5G NR Measured RMS EVM (dB and %) Versus Measured Average Power (dBm)

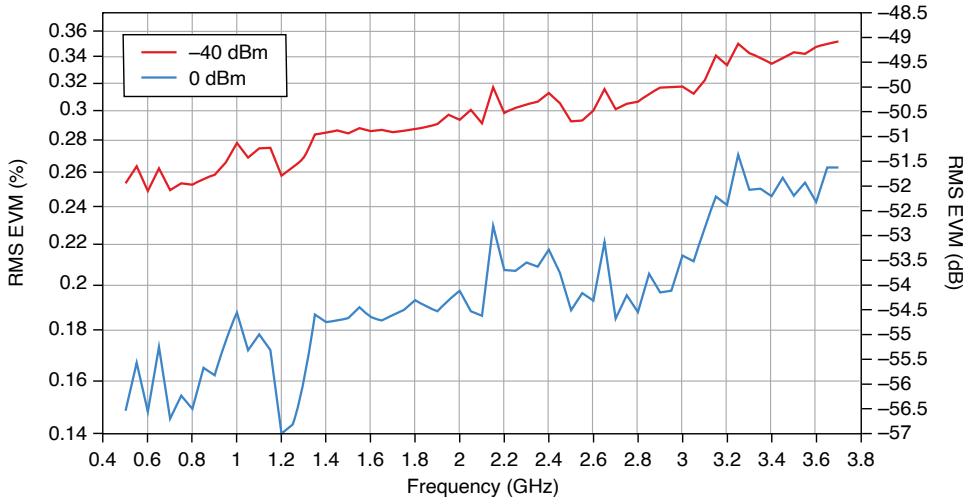


Conditions: RF output loopback to RF input; Reference/power level: average power +PAPR; Waveform bandwidth: 100 MHz; Subcarrier spacing: 30 kHz, uplink, 256 QAM; Offset Mode: Enabled; Reference Level Headroom: Default (1 dB); Measurement length:

3 slots

LTE

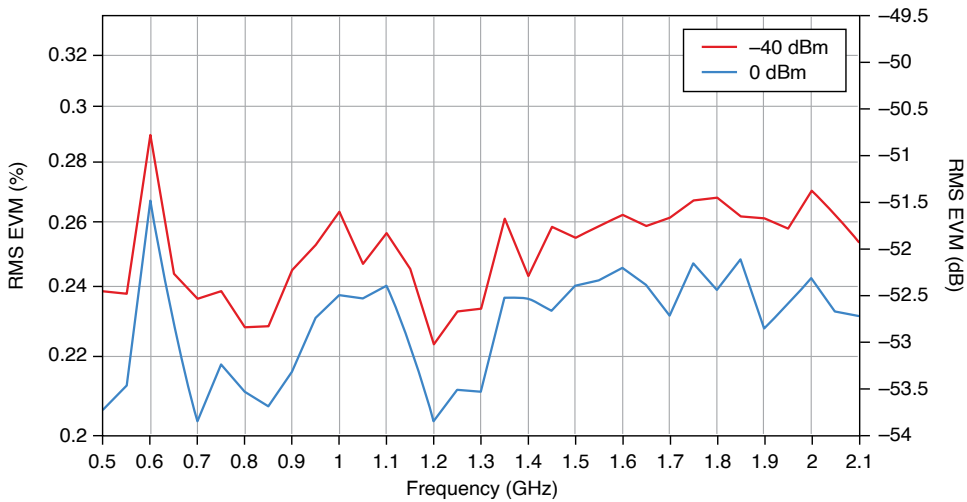
Figure 32. LTE Measured RMS EVM (dB and %) Versus Frequency (Hz)



Conditions: RF Output loopback to RF Input; Offset Mode: Enabled; Independent onboard LOs; 20 MHz BW, Uplink, FDD; Average power + PAPR

WCDMA

Figure 33. WCDMA Measured RMS EVM (dB and Percent) Versus Frequency (Hz)



Conditions: RF output loopback to RF input; Offset Mode: Enabled; Independent onboard LOs.

Baseband Characteristics

Converter Type	I/Q data rate
Analog-to-digital converters (ADCs)	19 kS/s to 1.25 GS/s
Digital-to-analog converters (DACs)	19 kS/s to 1.25 GS/s
(ADCs) Using fractional decimation below 1.25 GS/s.	
(DACs) Using fractional interpolation below 1.25 GS/s.	

Onboard FPGA

FPGA	Xilinx Virtex-7 X690T
LUTs	433,200
Flip-flops	866,400
DSP48 slices	3,600
Embedded block RAM	52.9 Mbits
Data transfers	DMA, interrupts, programmed I/O
Number of DMA channels	56

Onboard DRAM

Memory size	2 banks, 2 GB per bank
Theoretical maximum data rate	12 GB/s per bank

Onboard SRAM

Memory size	2 MB
Maximum data rate (read)	31 MB/s
Maximum data rate (write)	29 MB/s

Front Panel I/O



Note Refer to the *PXIe-5655 Specifications* for information on the PXIe-5655 front panel I/O.



Notice These test and measurement instruments are not intended for direct connection to the MAINS building installations of measurement categories CAT II, CAT III, and CAT IV.

RF IN

Connector	SMA (female)
-----------	--------------

Input impedance	50 Ω , nominal, AC coupled
Maximum DC input voltage without damage	± 10 VDC

Table 35. Absolute Maximum Input Power

<120 MHz	+24 dBm (CW RMS)
≥ 120 MHz	+33 dBm (CW RMS)

Input Return Loss (VSWR)

Table 36. Input Return Loss (dB) (Voltage Standing Wave Ratio), Typical

Frequency	Preamp Disabled	Preamp Enabled, Auto
100 kHz to <500 MHz	13.5 (1.51:1)	13.5 (1.51:1)
500 MHz to <1.2 GHz	15.0 (1.43:1)	13.5 (1.51:1)
1.2 GHz to <3.8 GHz	15.0 (1.43:1)	15.0 (1.43:1)
3.8 GHz to <4.2 GHz	15.0 (1.43:1)	13.5 (1.51:1)
4.2 GHz to <5.8 GHz	15.0 (1.43:1)	15.0 (1.43:1)
5.8 GHz to 6.0 GHz	13.5 (1.51:1)	13.5 (1.51:1)

RF OUT

Connector	SMA (female)
Output impedance	50 Ω , nominal, AC coupled

Table 37. Absolute Maximum Reverse Power

<120 MHz	+24 dBm (CW RMS)
≥ 120 MHz	+33 dBm (CW RMS)

Output Return Loss (VSWR)

Table 38. Output Return Loss (dB) (Voltage Standing Wave Ratio), Typical

Frequency	Typical
100 kHz to <500 MHz	12.0 (1.67:1)
500 MHz to <2.8 GHz	17.0 (1.33:1)
2.8 GHz to <4.5 GHz	14.5 (1.46:1)
4.5 GHz to <5.8 GHz	16.0 (1.38:1)
5.8 GHz to 6.0 GHz	15.0 (1.43:1)

LO OUT (RF IN and RF OUT)

Connectors	MMPX (female)
Frequency range	120 MHz to 6 GHz
Output power	0 dBm \pm 2 dB, typical
Output power resolution	0.25 dB, nominal
Output impedance	50 Ω , nominal, AC coupled



Note Output power resolution is the RF attenuator step size used to compensate for the LO output frequency response.

Table 39. Output Return Loss

120 MHz to 2 GHz	>12 dB (VSWR < 1.67:1), nominal
>2 GHz to 6 GHz	>8 dB (VSWR < 2.32:1), nominal

LO IN (RF IN and RF OUT)



Note The PXle-5841 supports receiving an external LO with a range of signal power levels. To properly configure the PXle-5841 LO signal path for the provided level, set `NIRFSA_ATTR_LO_IN_POWER` or `NIRFSG_ATTR_LO_IN_POWER`.

Connectors	MMPX (female)
Frequency range	120 MHz to 6 GHz
Input power range	-4 dBm to 0 dBm, nominal
Input impedance	50 Ω , nominal, AC coupled
Absolute maximum input power	+15 dBm
Maximum DC voltage	± 5 VDC

Table 40. Input Return Loss (LO IN Enabled)

120 MHz to 3.6 GHz	>20 dB (VSWR <1.22:1), nominal
>3.6 GHz to 6 GHz	>12 dB (VSWR <1.67:1), nominal

Table 41. Input Return Loss (LO IN Disabled)

120 MHz to 3 GHz	>18 dB (VSWR <1.29:1), nominal
>3 GHz to 6 GHz	>15 dB (VSWR <1.43:1), nominal

REF IN



Note $\text{Frequency Accuracy} = \text{Tolerance} \times \text{Reference Frequency}$

Connector	MMPX (female)
Frequency	10 MHz
Tolerance	$\pm 10 \times 10^{-6}$
Amplitude	0.7 V _{pk-pk} to 3.3 V _{pk-pk} into 50 Ω, typical.
Input impedance	50 Ω, nominal
Coupling	AC



Note Jitter performance improves with increased slew rate of input signal.

REF OUT



Note Refer to the [Internal Frequency Reference](#) section for accuracy.

Connector	MMPX (female)
Frequency	10 MHz, nominal

Amplitude	1.65 V _{pk-pk} into 50 Ω, nominal
Output impedance	50 Ω, nominal
Coupling	AC

PFI 0

Connector	MMPX (female)
Input impedance	10 kΩ, nominal
Output impedance	50 Ω, nominal
Maximum DC drive strength	24 mA



Note Voltage levels are guaranteed by design through the digital buffer specifications.

Table 42. Voltage Levels

Absolute maximum input range	-0.5 V to 5.5 V
V _{IL} , maximum	0.8 V
V _{IH} , minimum	2.0 V
V _{OL} , maximum	0.2 V with 100 μA load
V _{OH} , minimum	2.9 V with 100 μA load

DIGITAL I/O

Connector	Molex Nano-Pitch I/O
5.0 V Power	$\pm 5\%$, 50 mA maximum, nominal

Table 43. DIGITAL I/O Signal Characteristics

Signal	Type	Direction
MGT Tx \pm <3..0>	Xilinx Virtex-7 GTH	Output
MGT Rx \pm <3..0>	Xilinx Virtex-7 GTH	Input
MGT REF \pm	Differential	Input
DIO <1..0>	Single-ended	Bidirectional
DIO <7..2>	Single-ended	Bidirectional
5.0 V	DC	Output
GND	Ground	—



Note DIO <1..0> pins are multiplexed with MGT REF \pm .

Digital I/O Single-Ended Channels

Number of channels	8
Signal type	Single-ended
Voltage families	3.3 V, 2.5 V, 1.8 V, 1.5 V, 1.2 V
Output impedance	50 Ω , nominal

Direction control	Per channel
Minimum required direction change latency	200 ns
Maximum output toggle rate	60 MHz with 100 μ A load, nominal

Table 44. Input Impedance

DIO <1..0>	10 k Ω , nominal
DIO <7..2>	100 k Ω , nominal



Note Voltage levels are guaranteed by design through the digital buffer specifications.

Table 45. DIGITAL I/O Single-Ended DC Signal Characteristics

Voltage Family	V _{IL} Max	V _{IH} Min	V _{OL} Max (100 μ A load)	V _{OH} Min (100 μ A load)	Maximum DC Drive Strength
3.3 V	0.8 V	2.0 V	0.2 V	3.0 V	24 mA
2.5 V	0.7 V	1.6 V	0.2 V	2.2 V	18 mA
1.8 V	0.62 V	1.29 V	0.2 V	1.5 V	16 mA
1.5 V	0.51 V	1.07 V	0.2 V	1.2 V	12 mA
1.2 V	0.42 V	0.87 V	0.2 V	0.9 V	6 mA

Digital I/O High Speed Serial MGT



Note For detailed FPGA and High Speed Serial Link specifications, refer to Xilinx documentation.

Data rate	500 Mbps to 12 Gbps, nominal
Number of Tx channels	4
Number of Rx channels	4
I/O AC coupling capacitor	100 nF

MGT Tx± <3..0> Channels

Minimum differential output voltage	800 mV _{pk-pk} into 100 Ω, nominal
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Conditions: transmitter output swing at maximum setting.

MGT Rx± <3..0> Channels

Table 46. Differential Input Voltage Range

≤6.6 GB/s	150 mV _{pk-pk} to 2,000 mV _{pk-pk} , nominal
>6.6 GB/s	150 mV _{pk-pk} to 1,250 mV _{pk-pk} , nominal

Differential input resistance	100 Ω, nominal
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MGT Reference Clock



Note Internal MGT Reference is derived from the Sample Clock PLL. Available frequencies are 2.5 GHz / N , where $4 \leq N \leq 32$. Set via MGT

component level IP (CLIP).

Table 47. Clocking Resources

Data Clock	156.25 MHz
MGT REF \pm Input	60 MHz to 820 MHz, nominal

MGT REF \pm Input

AC coupling capacitors	100 nF
Differential input resistance	100 Ω , nominal
Differential input V_{pk-pk} range	350 mV to 2000 mV, nominal
Absolute maximum input range	-1.25 V to 4.5 V



Note Absolute maximum levels measured at input, prior to AC coupling capacitors.

Figure 34. DIGITAL I/O Nano-Pitch Connector

Reserved	A1	B1	5.0 V
GND	A2	B2	GND
MGT Rx+ 0	A3	B3	MGT Tx+ 0
MGT Rx− 0	A4	B4	MGT Tx− 0
GND	A5	B5	GND
MGT Rx+ 1	A6	B6	MGT Tx+ 1
MGT Rx− 1	A7	B7	MGT Tx− 1
GND	A8	B8	GND
DIO 4	A9	B9	DIO 6
DIO 5	A10	B10	DIO 7
GND	A11	B11	GND
MGT REF+ / DIO 0	A12	B12	DIO 2
MGT REF− / DIO 1	A13	B13	DIO 3
GND	A14	B14	GND
MGT Rx+ 2	A15	B15	MGT Tx+ 2
MGT Rx− 2	A16	B16	MGT Tx− 2
GND	A17	B17	GND
MGT Rx+ 3	A18	B18	MGT Tx+ 3
MGT Rx− 3	A19	B19	MGT Tx− 3
GND	A20	B20	GND
5.0 V	A21	B21	Reserved

Power Requirements



Note Refer to the *PXIe-5655 Specifications* for information on the PXIe-5655 power requirements.

Table 48. Power Requirements

Voltage (V _{DC})	Typical Current (A)
+3.3	3.3
+12	5.8

Power is 80 W, typical. Consumption is from both PXI Express backplane power connectors.

Conditions: Simultaneous generation and acquisition using NI-RFSG and NI-RFSA at 1.25 GS/s IQ rate, 45 °C ambient temperature. Power consumption depends on FPGA image being used.

Environmental Characteristics

Temperature and Humidity

Table 49. Operating Temperature

Chassis with slot cooling capacity ≥ 58 W	0 °C to 55 °C
All other compatible chassis	0 °C to 40 °C

Conditions (chassis with slot cooling capacity ≥ 58 W): tested with chassis fan mode set to Auto and cooling profile set to 58 W/82 W in NI MAX. Not all chassis with slot cooling capacity ≥ 58 W can achieve this ambient temperature range. Refer to PXI chassis specifications to determine the ambient temperature ranges your chassis can achieve.

Conditions (all other compatible chassis): for chassis with slot cooling capacity = 38 W, the fan speed must be set to HIGH to achieve this ambient temperature range.

Operating Humidity	10% to 90%, noncondensing
Storage Humidity	5% to 95%, noncondensing

Pollution Degree	2
Maximum altitude	2,000 m (800 mbar) (at 25 °C ambient temperature)

Shock and Vibration

Random vibration (operating)	5 Hz to 500 Hz, 0.3 g RMS
Random vibration (non-operating)	5 Hz to 500 Hz, 2.4 g RMS
Operating shock	30 g, half-sine, 11 ms pulse

Environmental Management


NI is committed to designing and manufacturing products in an environmentally responsible manner. NI recognizes that eliminating certain hazardous substances from our products is beneficial to the environment and to NI customers.

For additional environmental information, refer to the *Engineering a Healthy Planet* web page at ni.com/environment. This page contains the environmental regulations and directives with which NI complies, as well as other environmental information not included in this document.

EU and UK Customers

- ~~X~~ **Waste Electrical and Electronic Equipment (WEEE)**—At the end of the product life cycle, all NI products must be disposed of according to local laws and regulations. For more information about how to recycle NI products in your region, visit ni.com/environment/weee.

电子信息产品污染控制管理办法（中国RoHS）

-  **中国RoHS**— NI符合中国电子信息产品中限制使用某些有害物质指令 (RoHS)。关于NI中国RoHS合规性信息，请登录 ni.com/environment/rohs_china。 (For information about China RoHS compliance, go to ni.com/environment/rohs_china.)

Calibration

Interval	1 year
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Note For the two-year calibration interval, add 0.2 dB to one year specifications for *RF Input Absolute Amplitude Accuracy*, *RF Input Frequency Response*, *RF Output Power Level Accuracy*, and *RF Output Frequency Response*.